

Infrared absorption of femtosecond laser doped silicon

CSSC-5

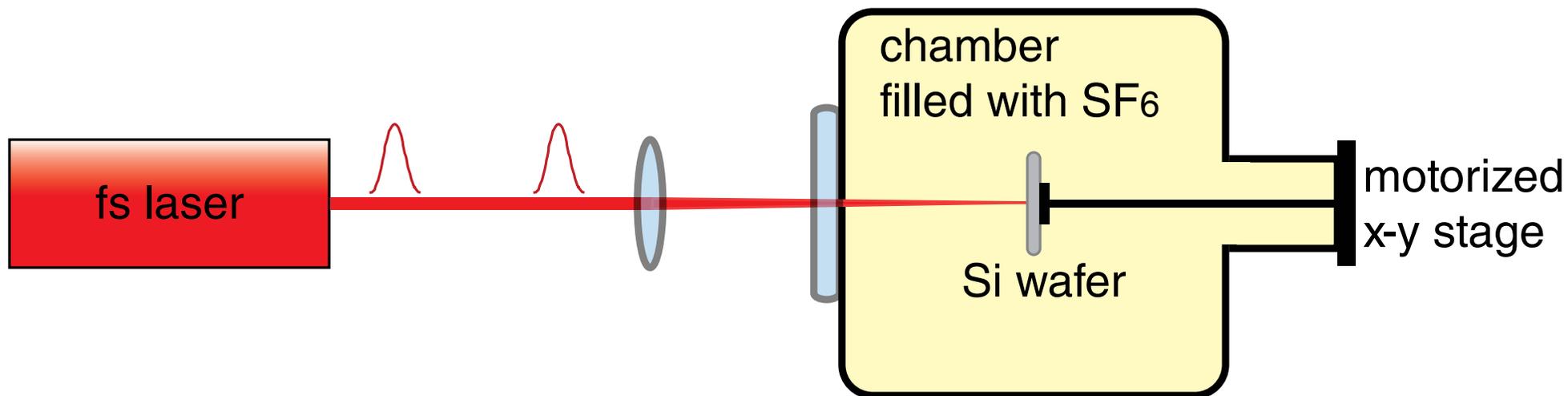
Boston, MA 2011/11/02

Meng-Ju Sher, Yu-Ting Lin, Mark Winkler, and Eric Mazur
Harvard University

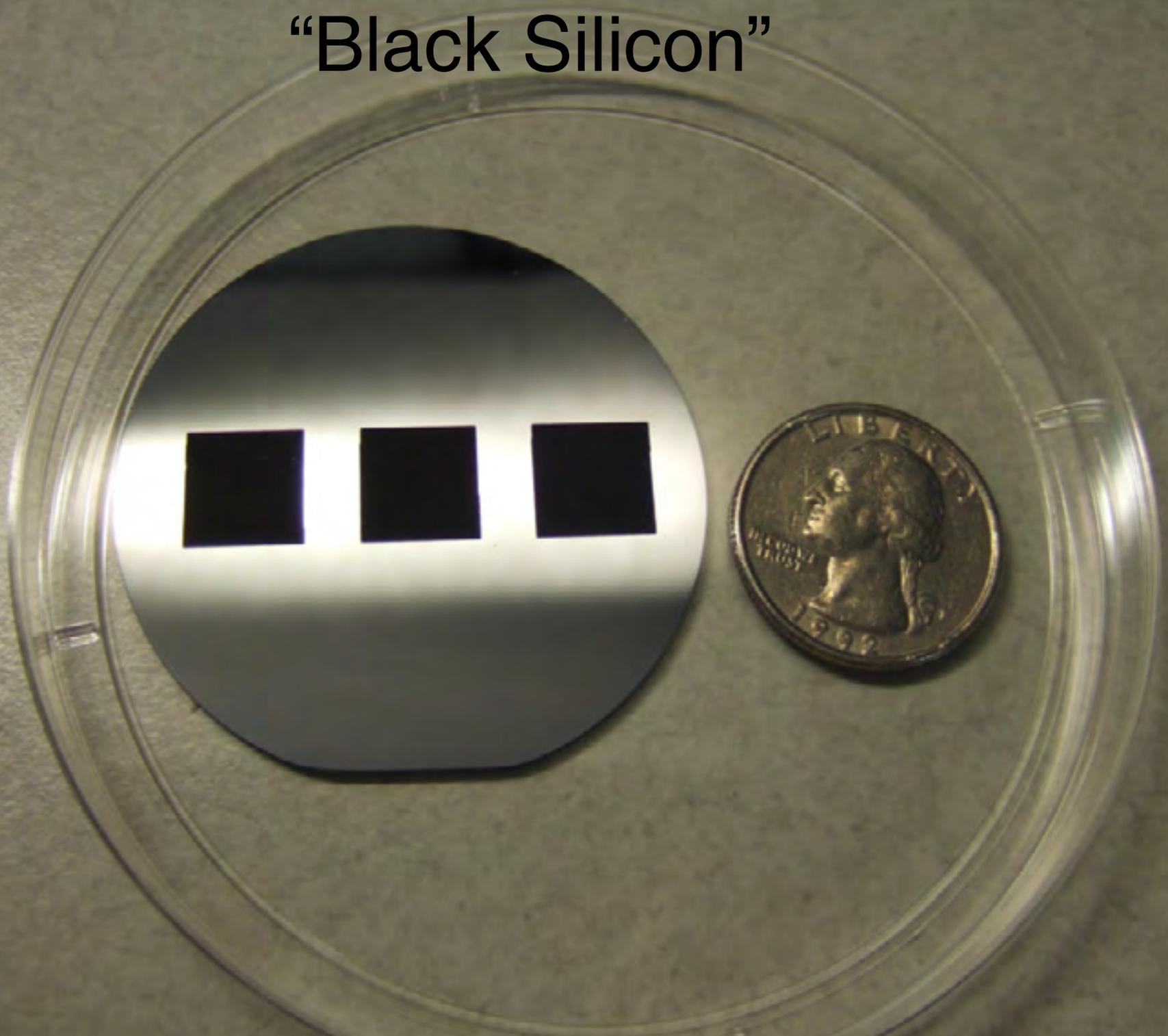
Christian Pruner and Augustinus Asenbaum
University of Salzburg , Salzburg, Austria



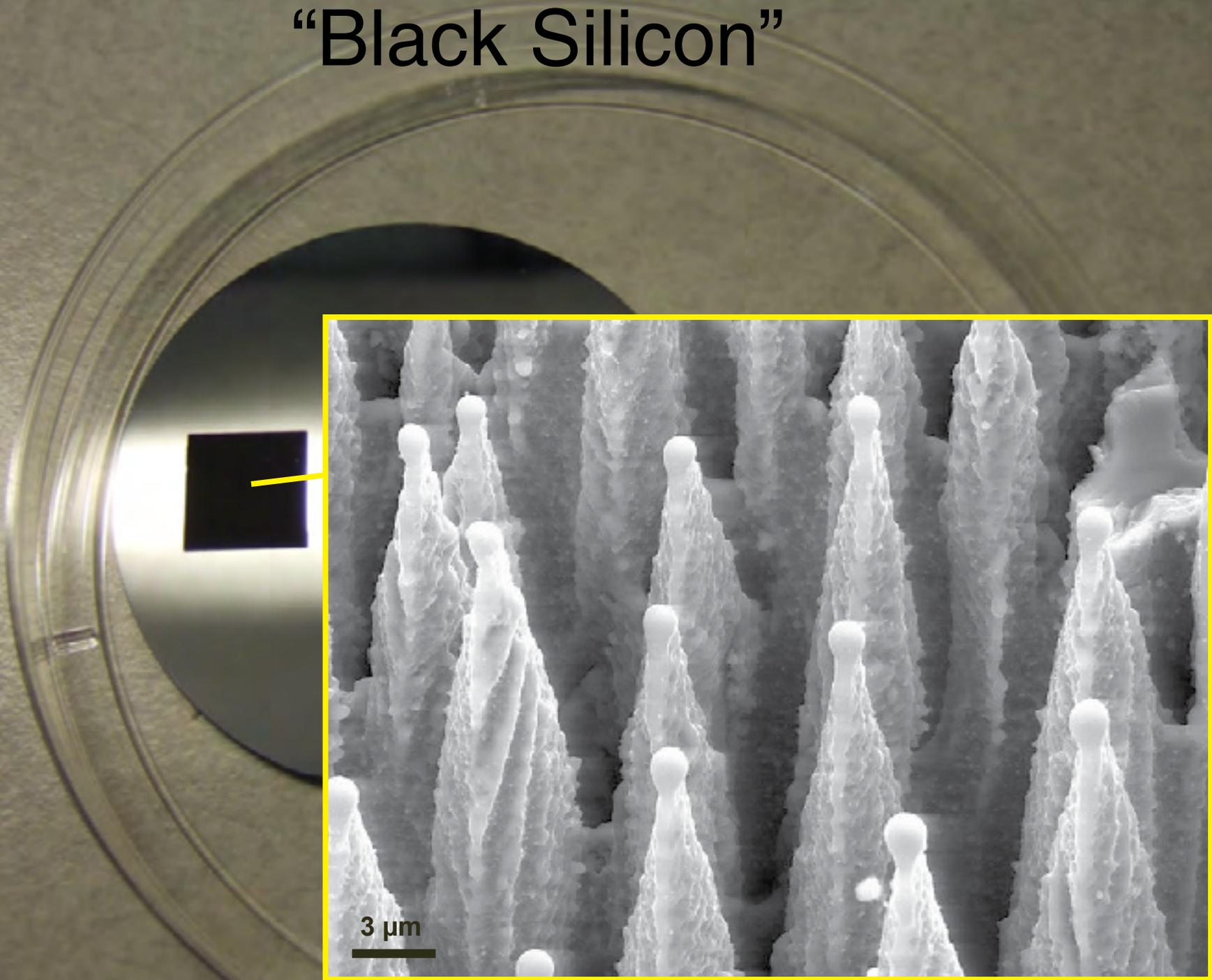
“Black Silicon”



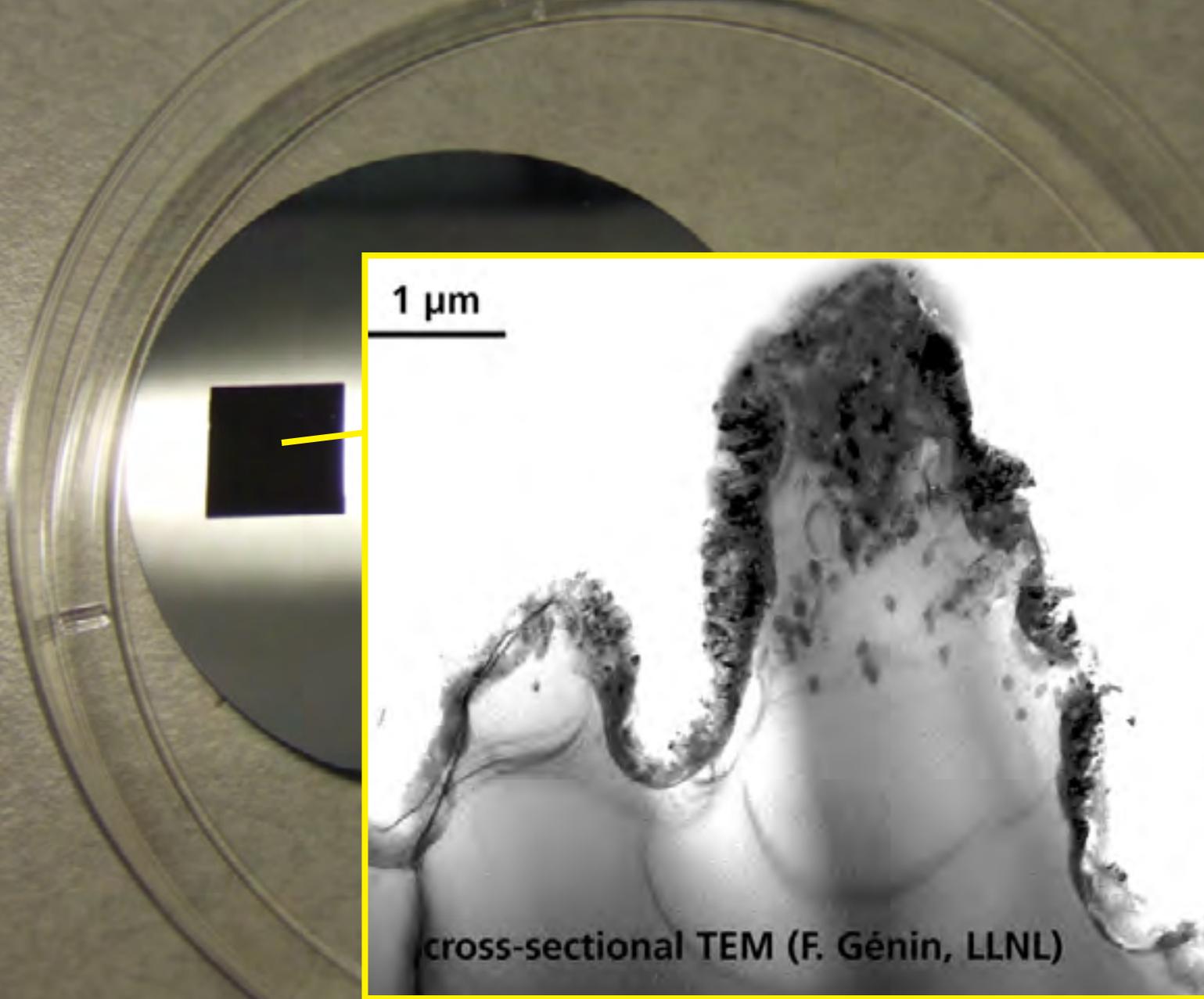
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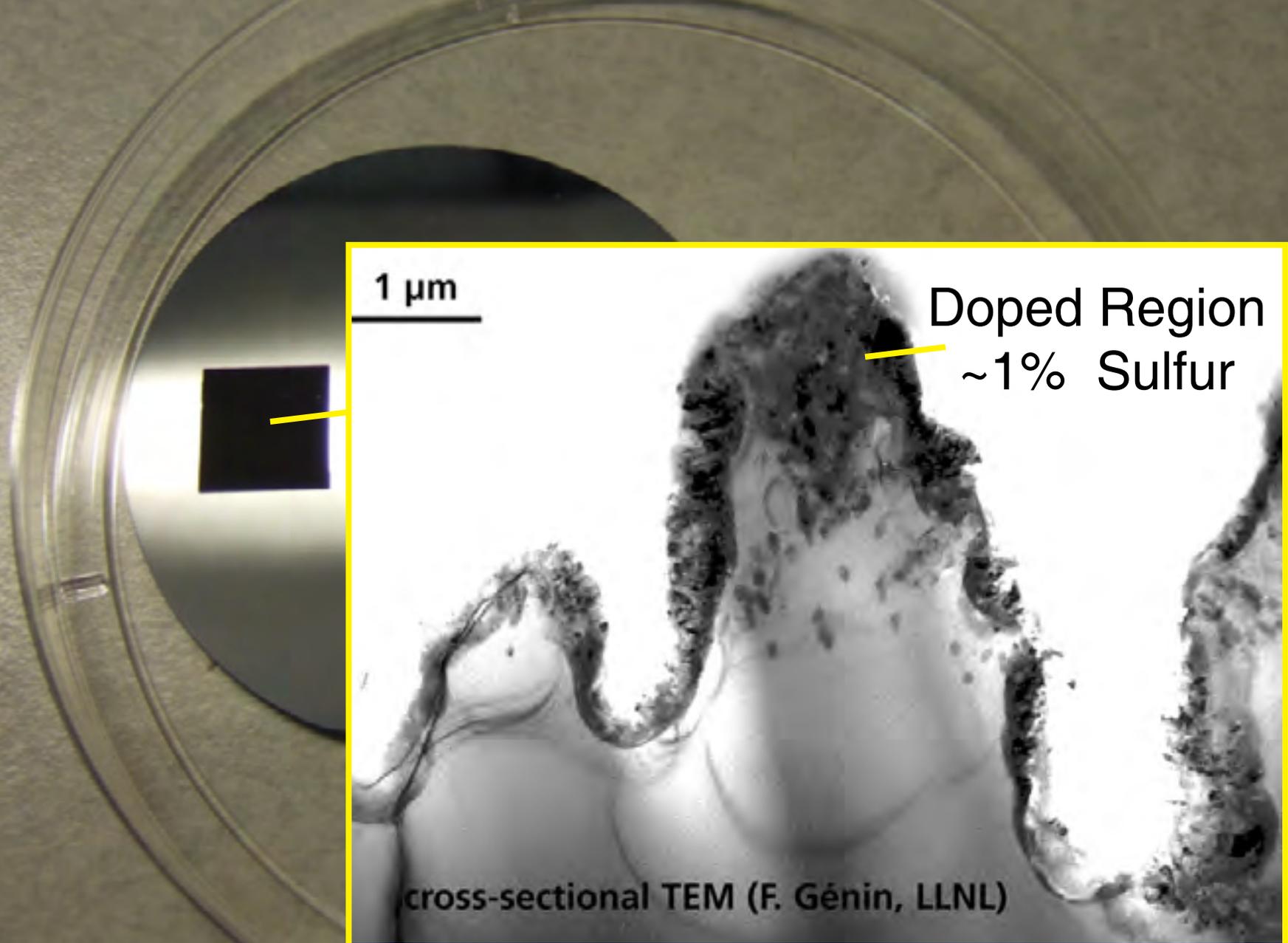
“Black Silicon”



“Black Silicon”

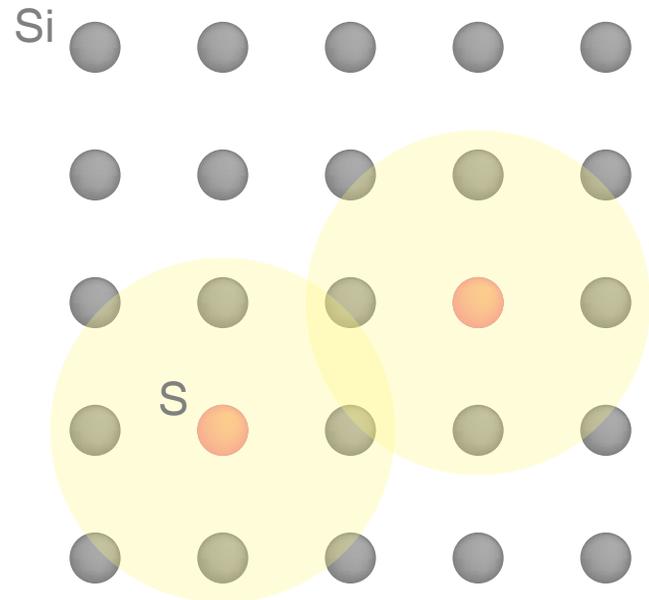


“Black Silicon”

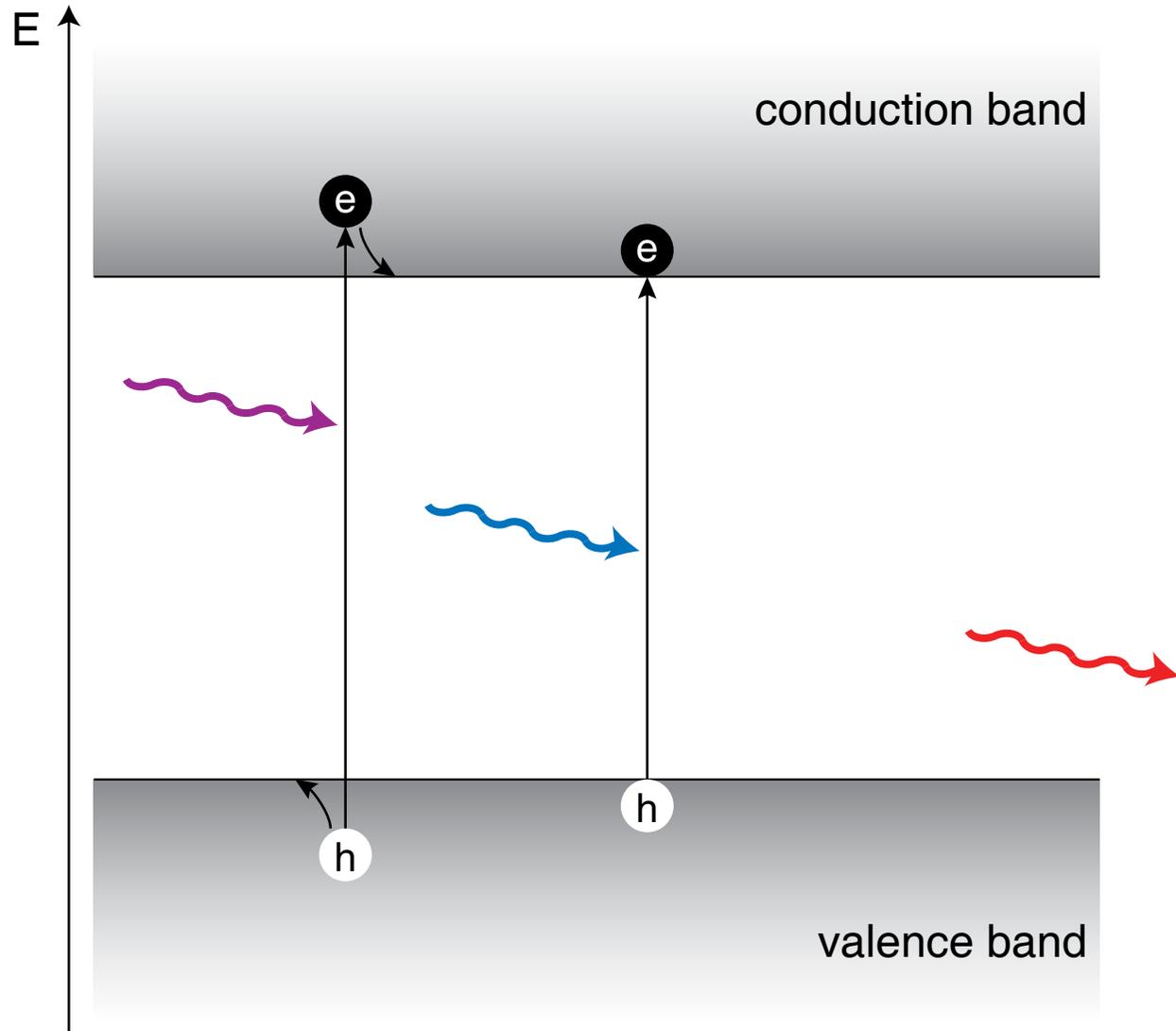


Outline

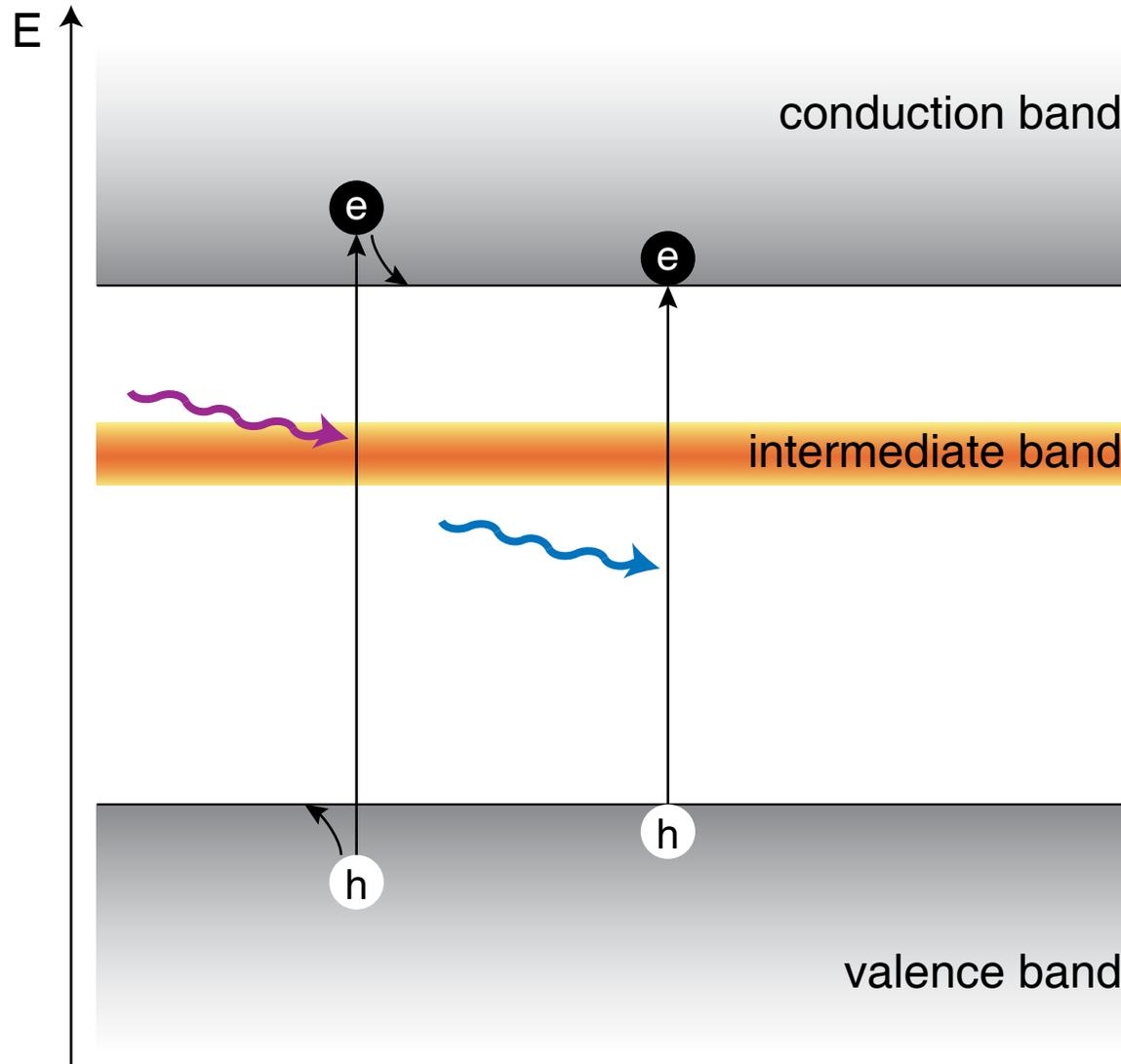
- fs-laser hyperdoping and texturing
- intermediate band PV
- infrared absorption
- dopant diffusion



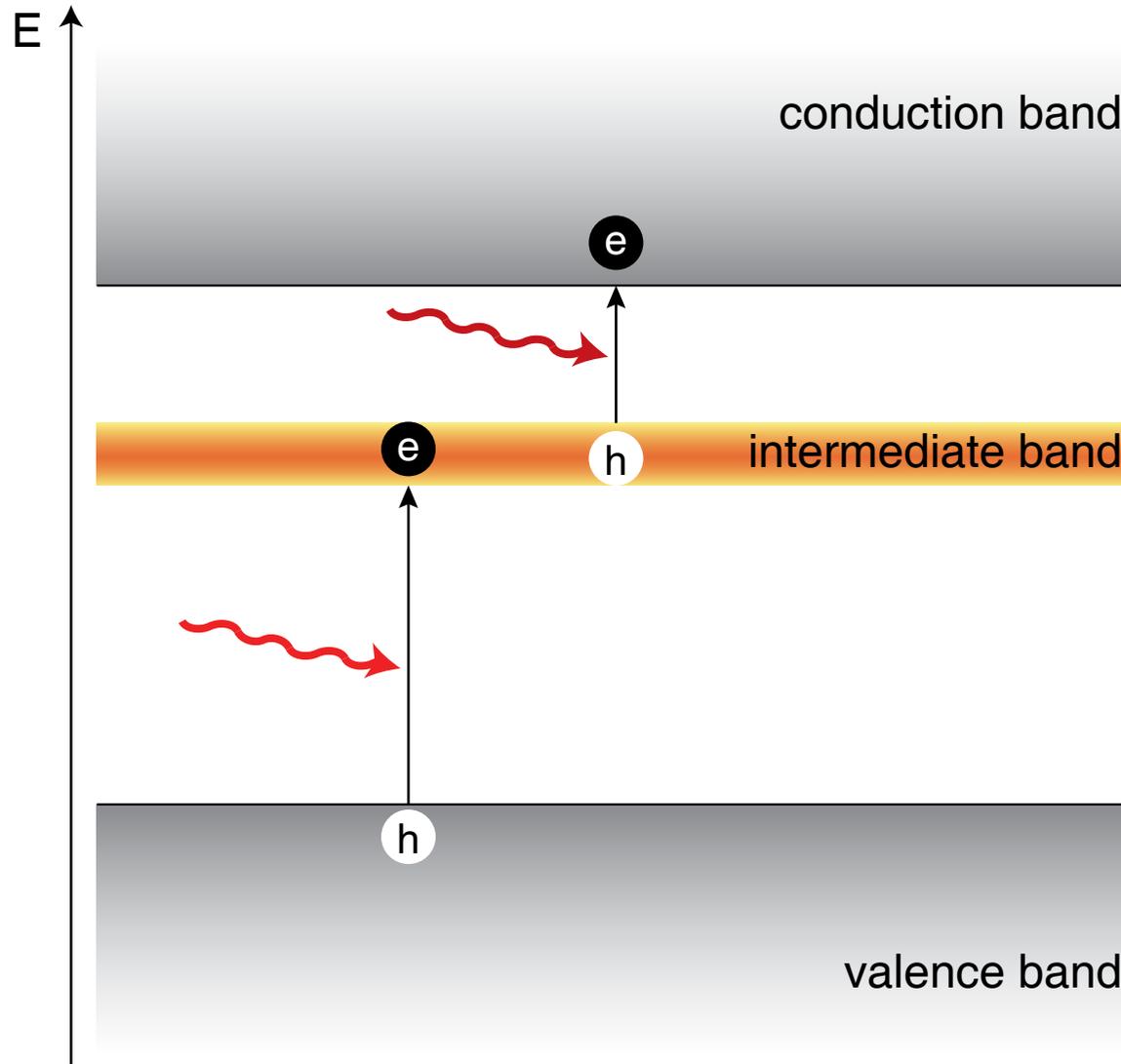
Intermediate-band photovoltaics



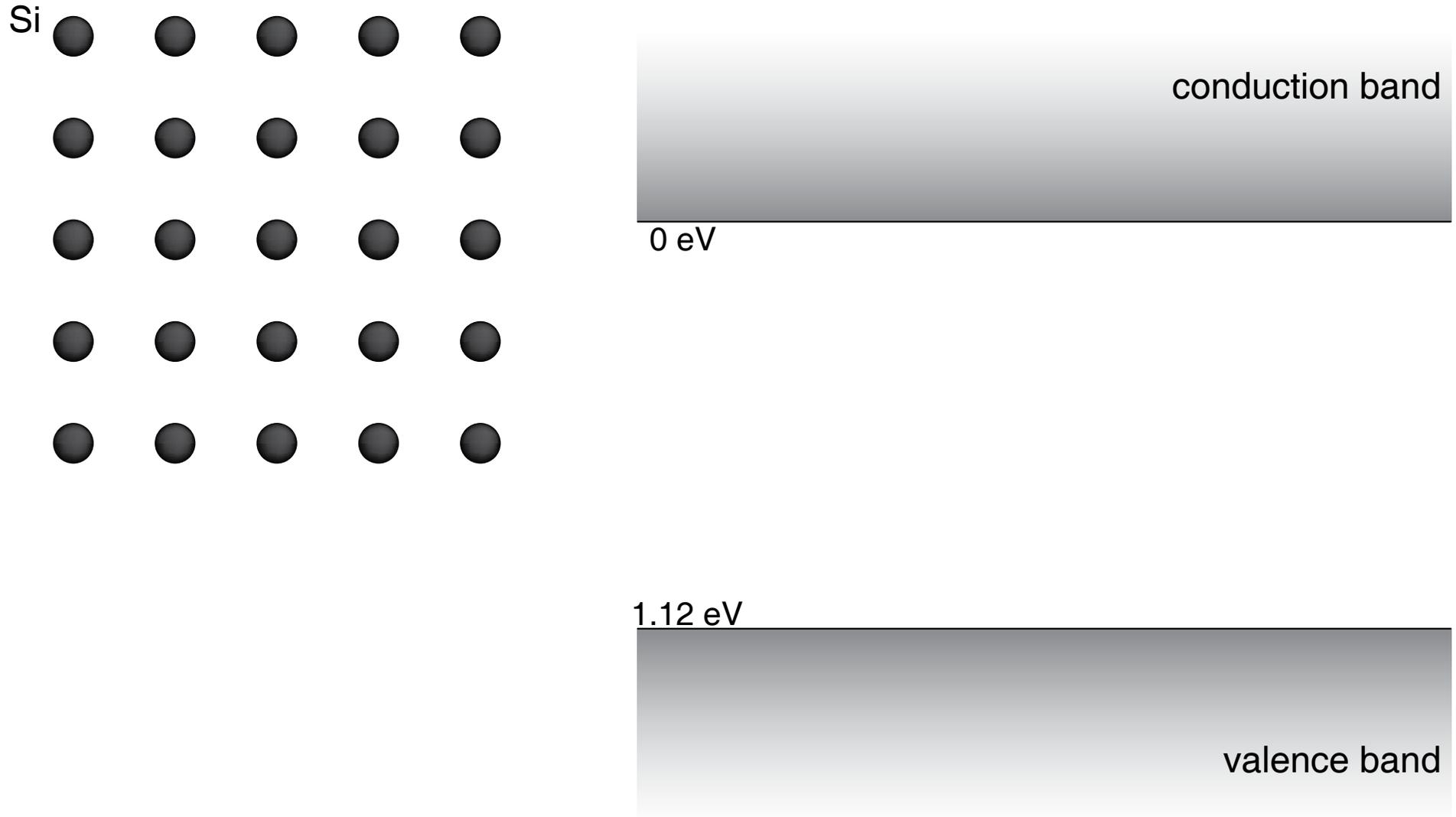
Intermediate-band photovoltaics



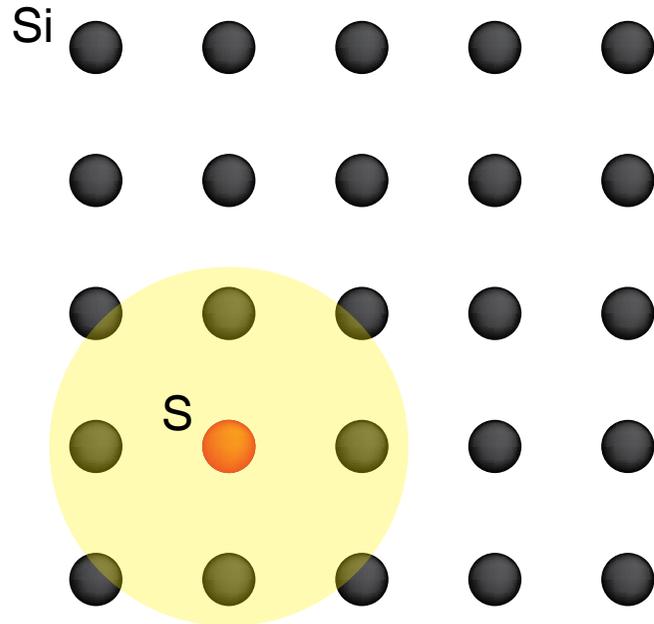
Intermediate-band photovoltaics



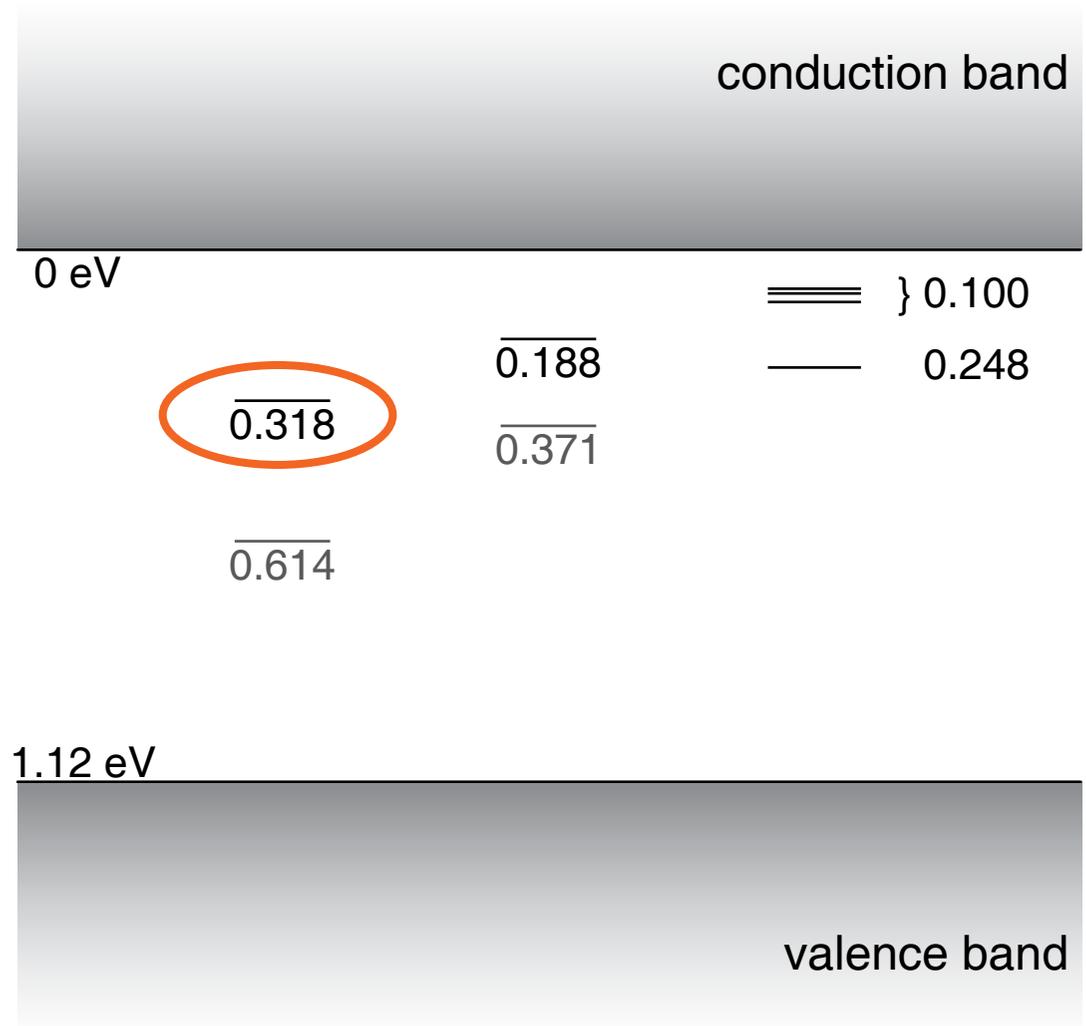
Intermediate-band photovoltaics



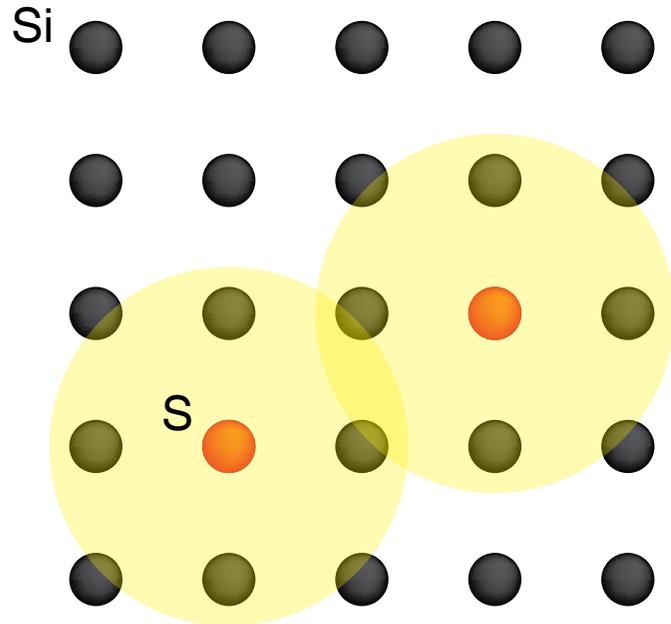
Intermediate-band photovoltaics



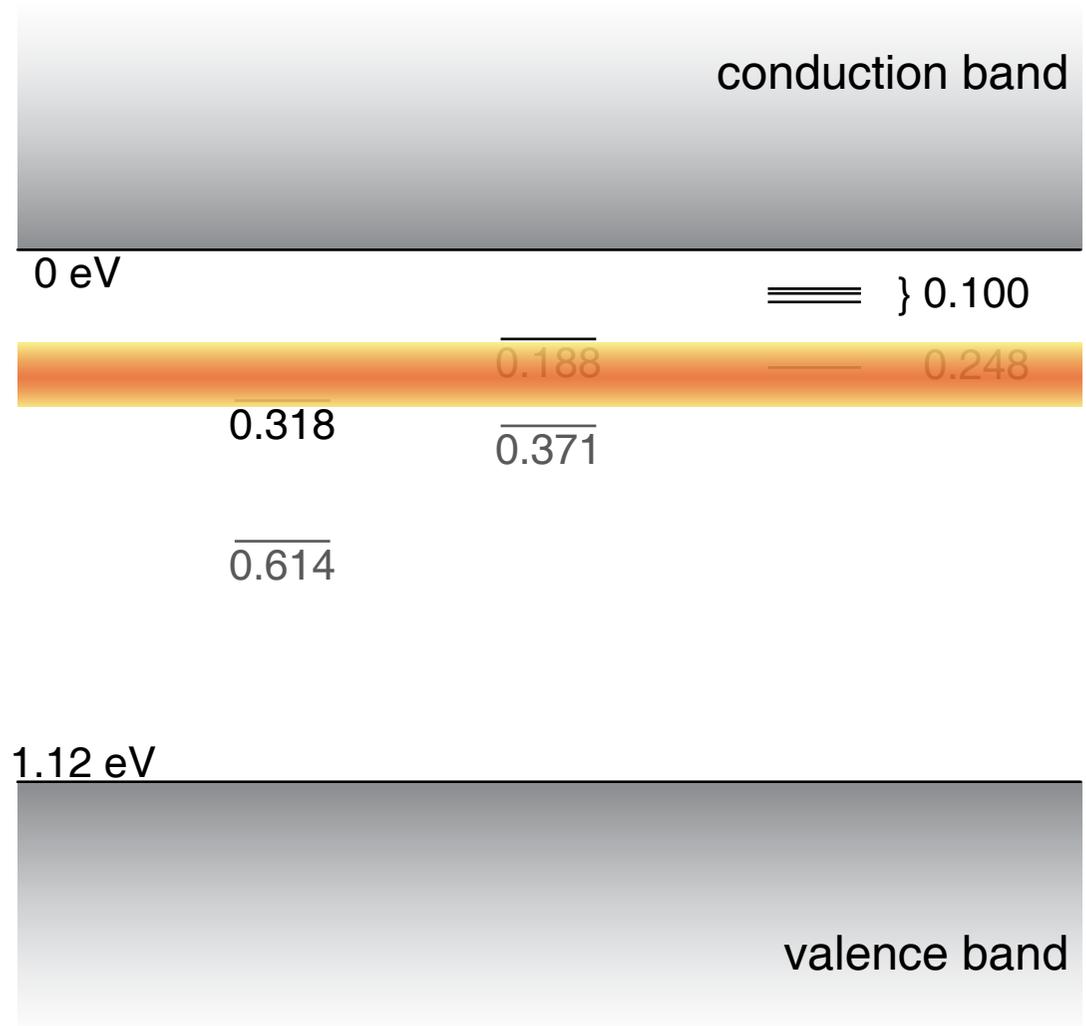
sulfur energy levels



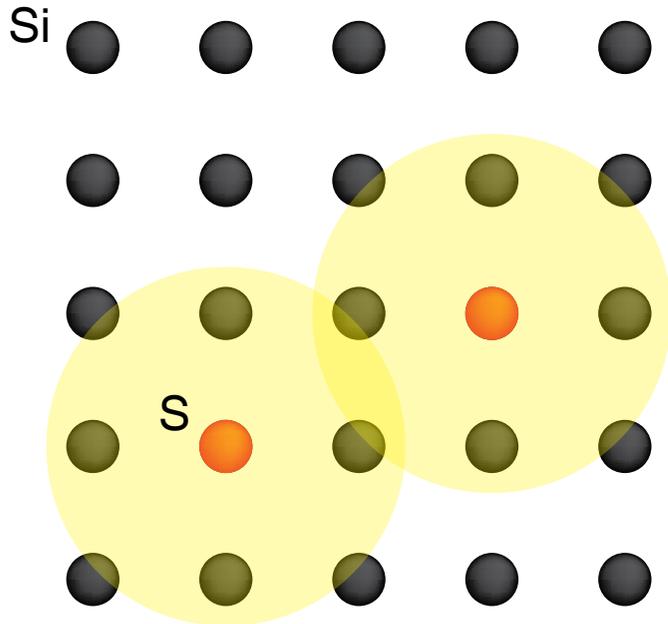
Intermediate-band photovoltaics



metal-insulator transition

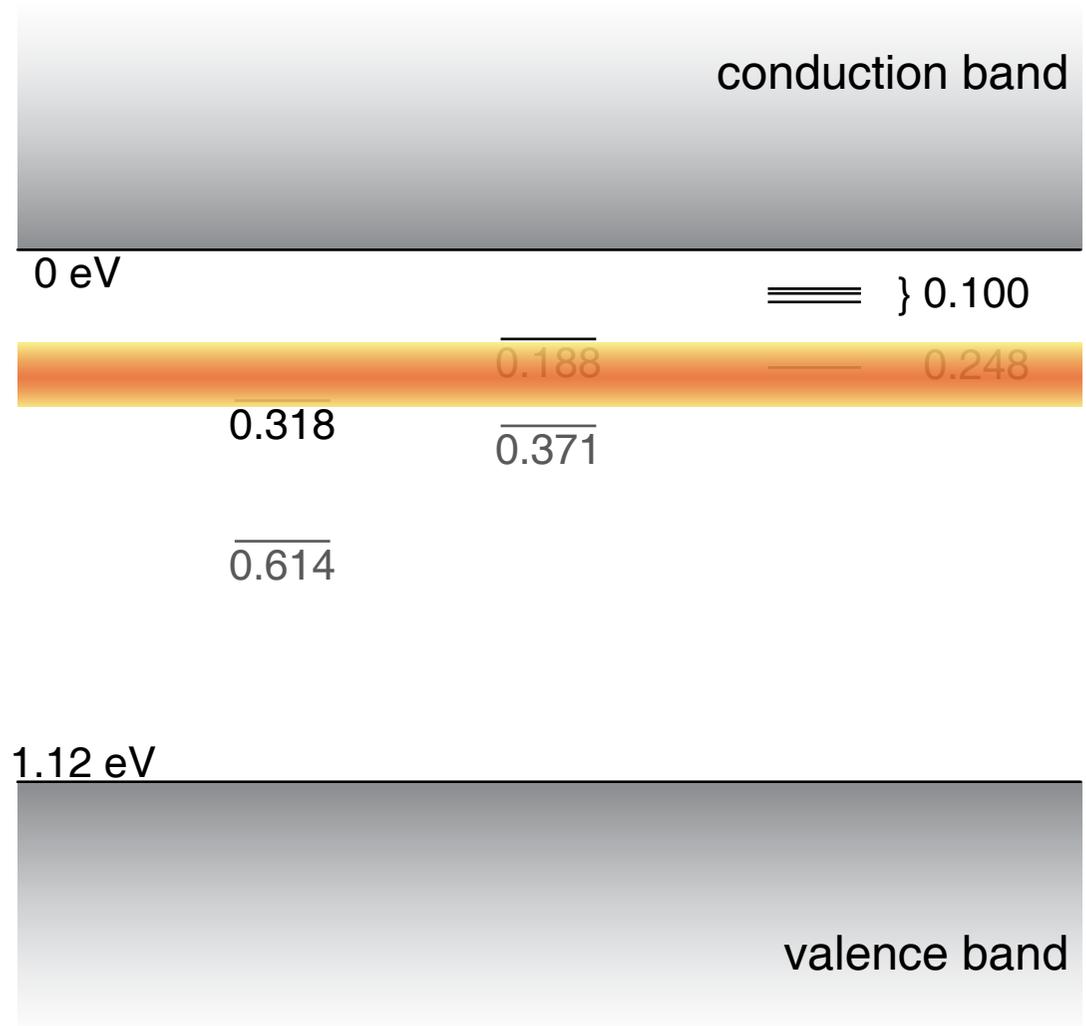


Intermediate-band photovoltaics



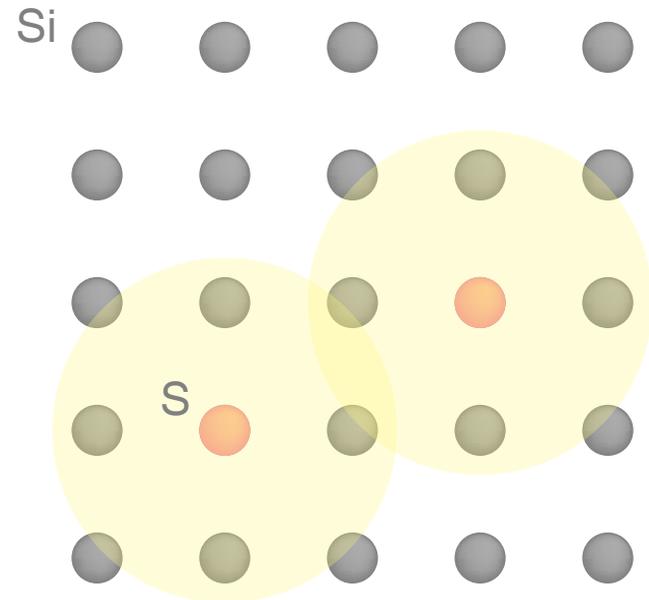
deep level
high concentration

metal-insulator transition



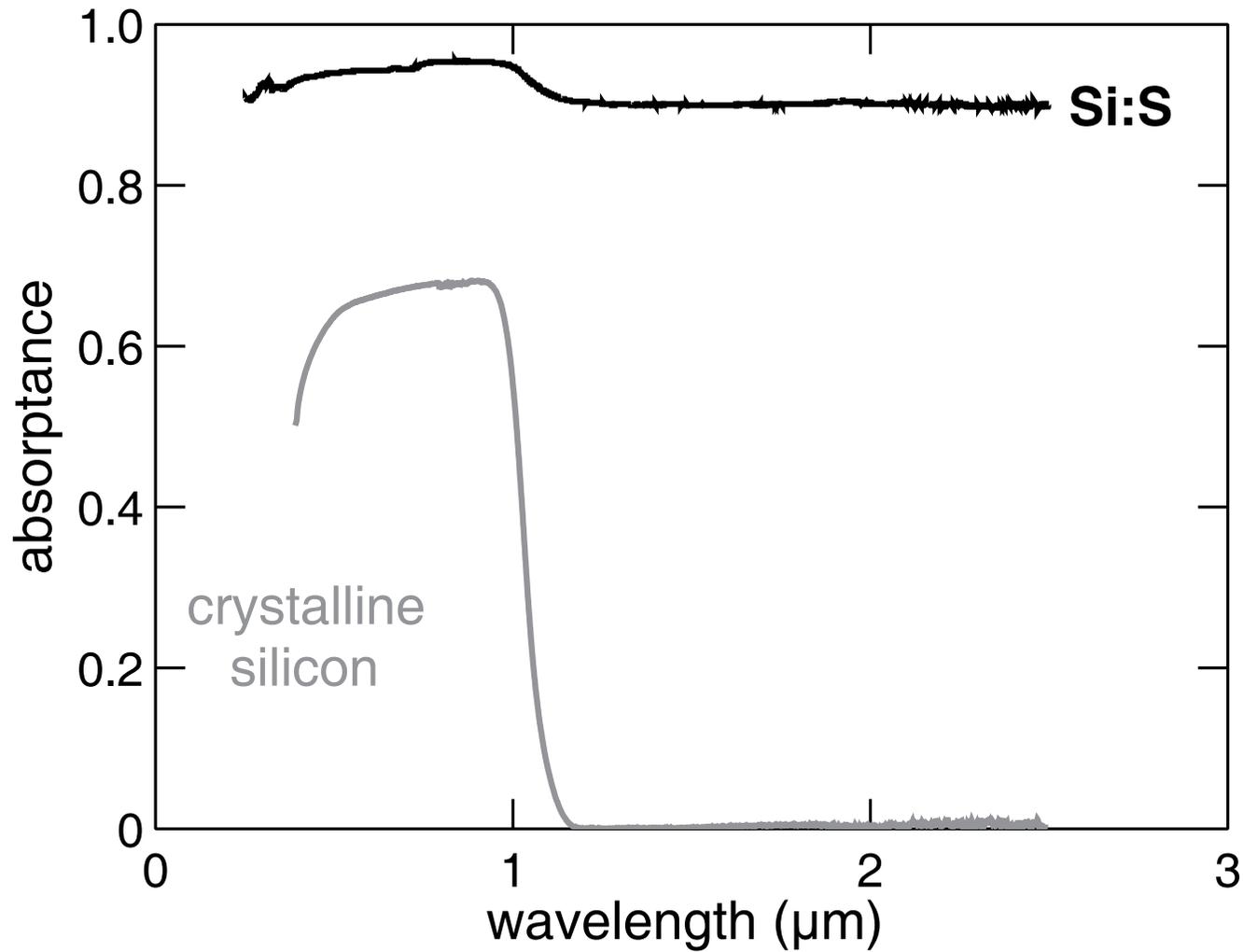
Outline

- fs-laser hyperdoping and texturing
- intermediate band PV
- infrared absorption
- dopant diffusion



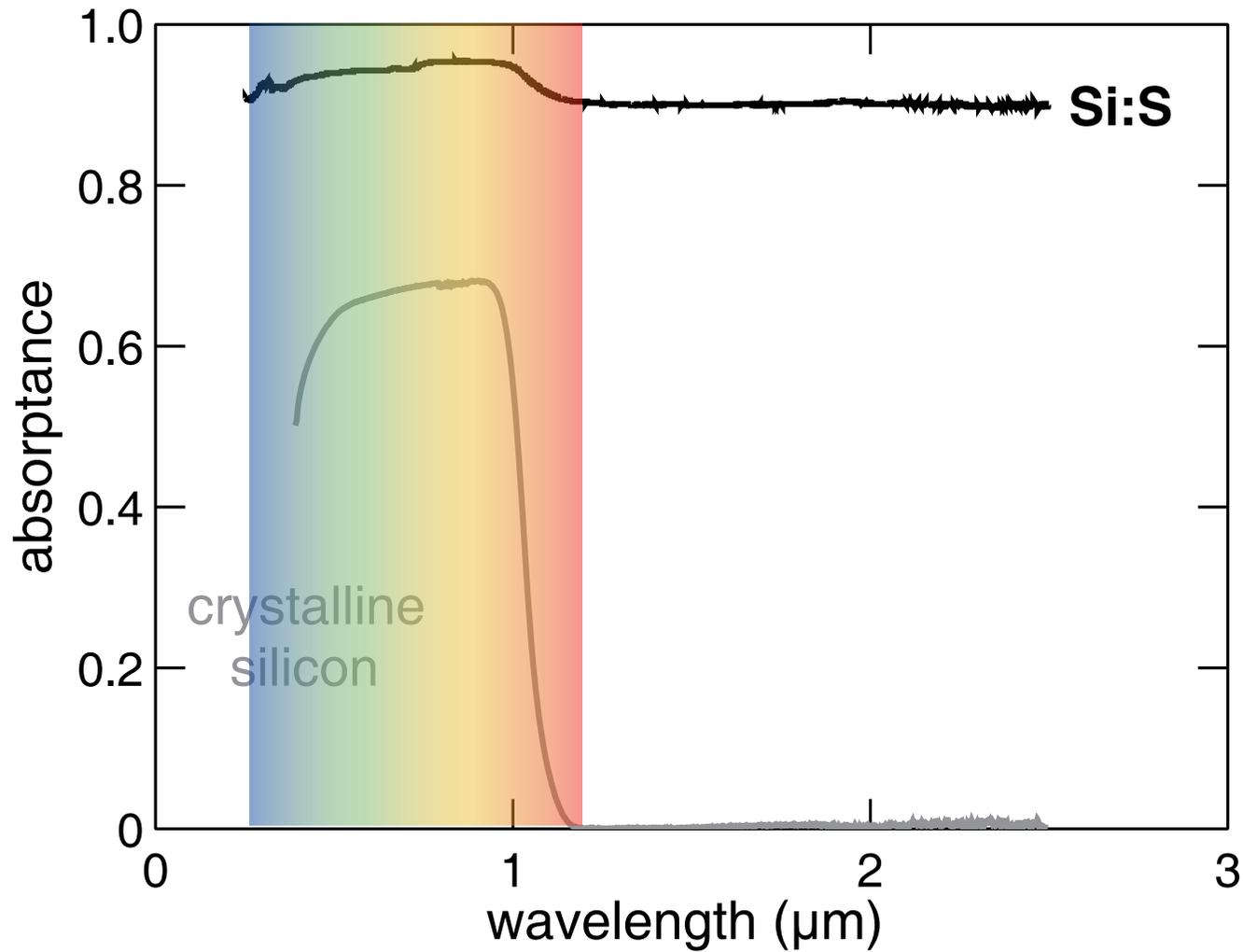
IR absorption

$$A = 1 - T_{int} - R_{int}$$



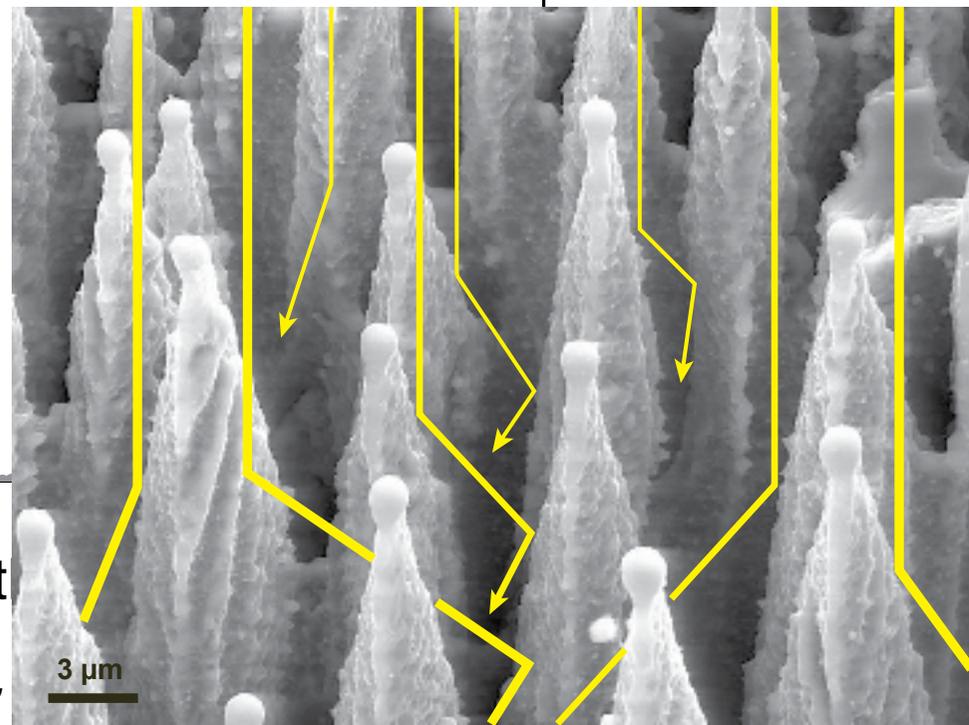
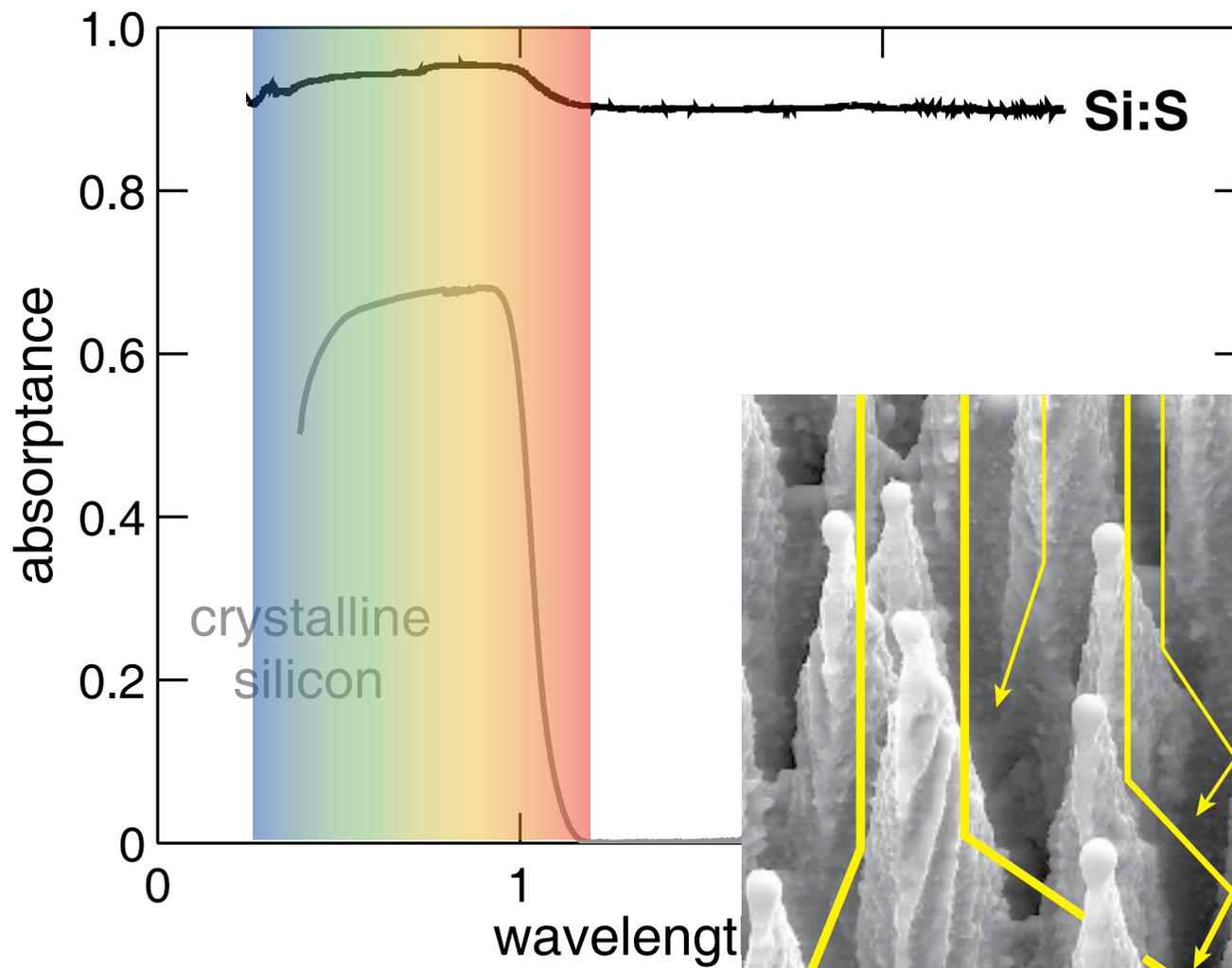
IR absorption

$$A = 1 - T_{int} - R_{int}$$



IR absorption

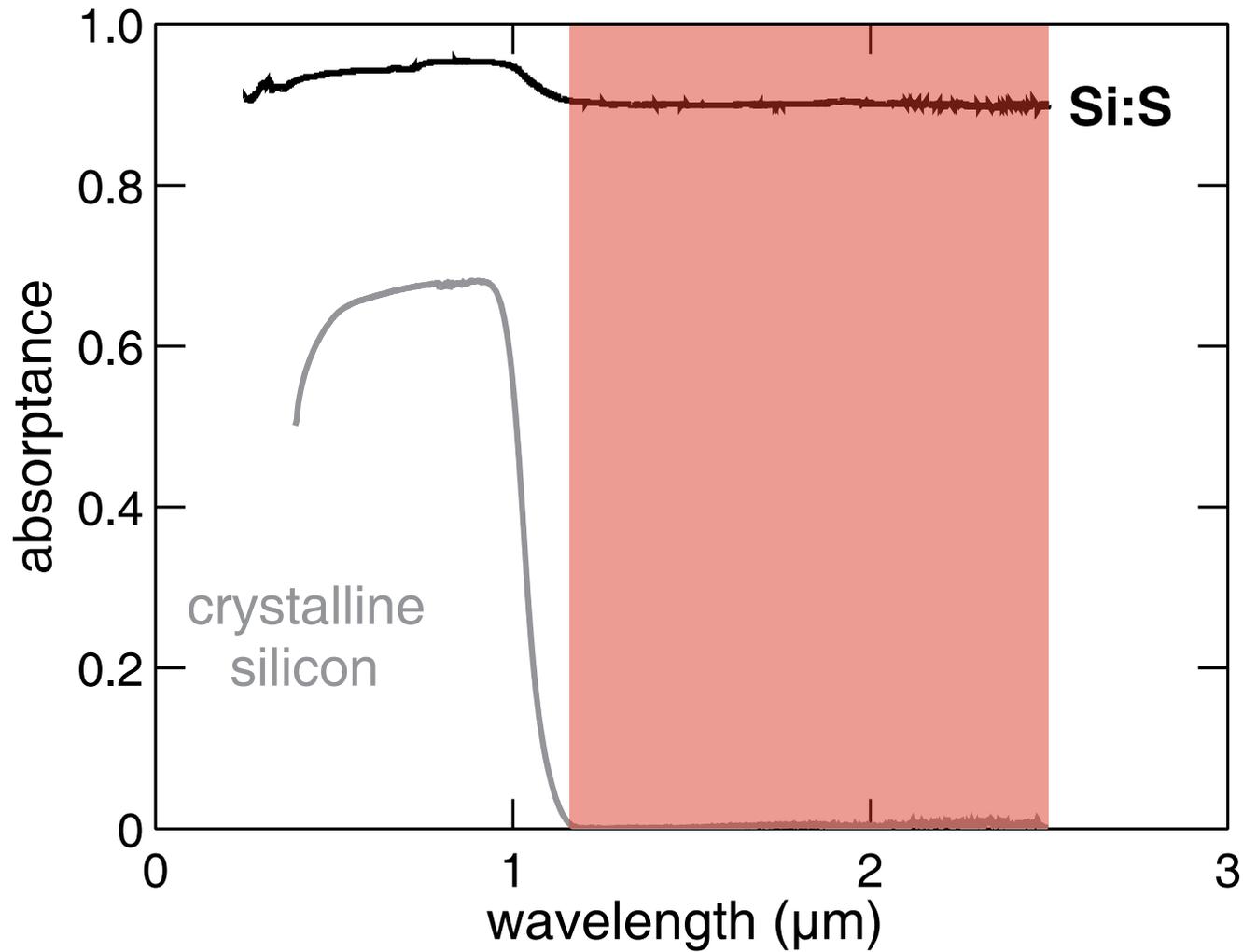
$$A = 1 - T_{int} - R_{int}$$



Sheehy *et al*,

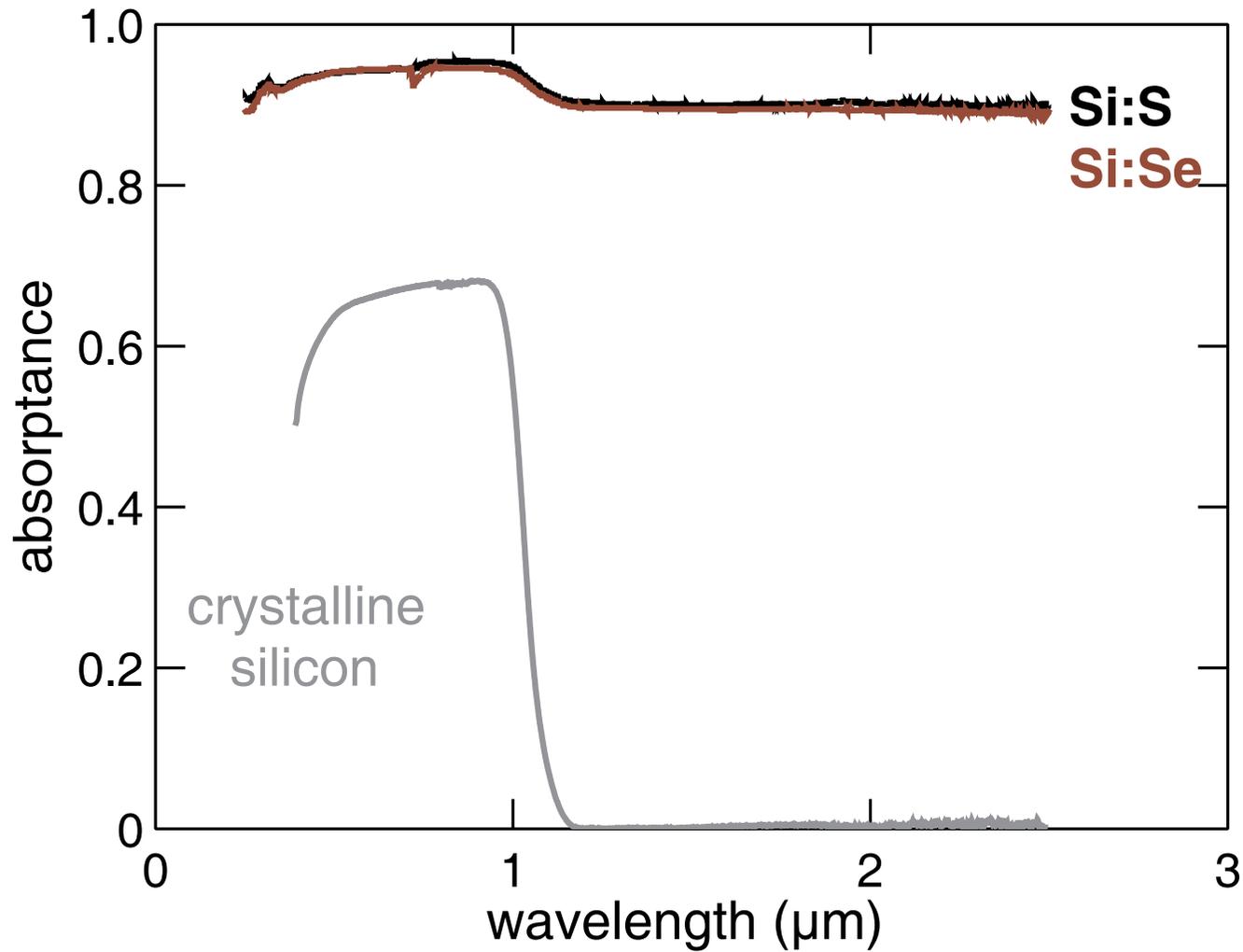
IR absorption

$$A = 1 - T_{int} - R_{int}$$



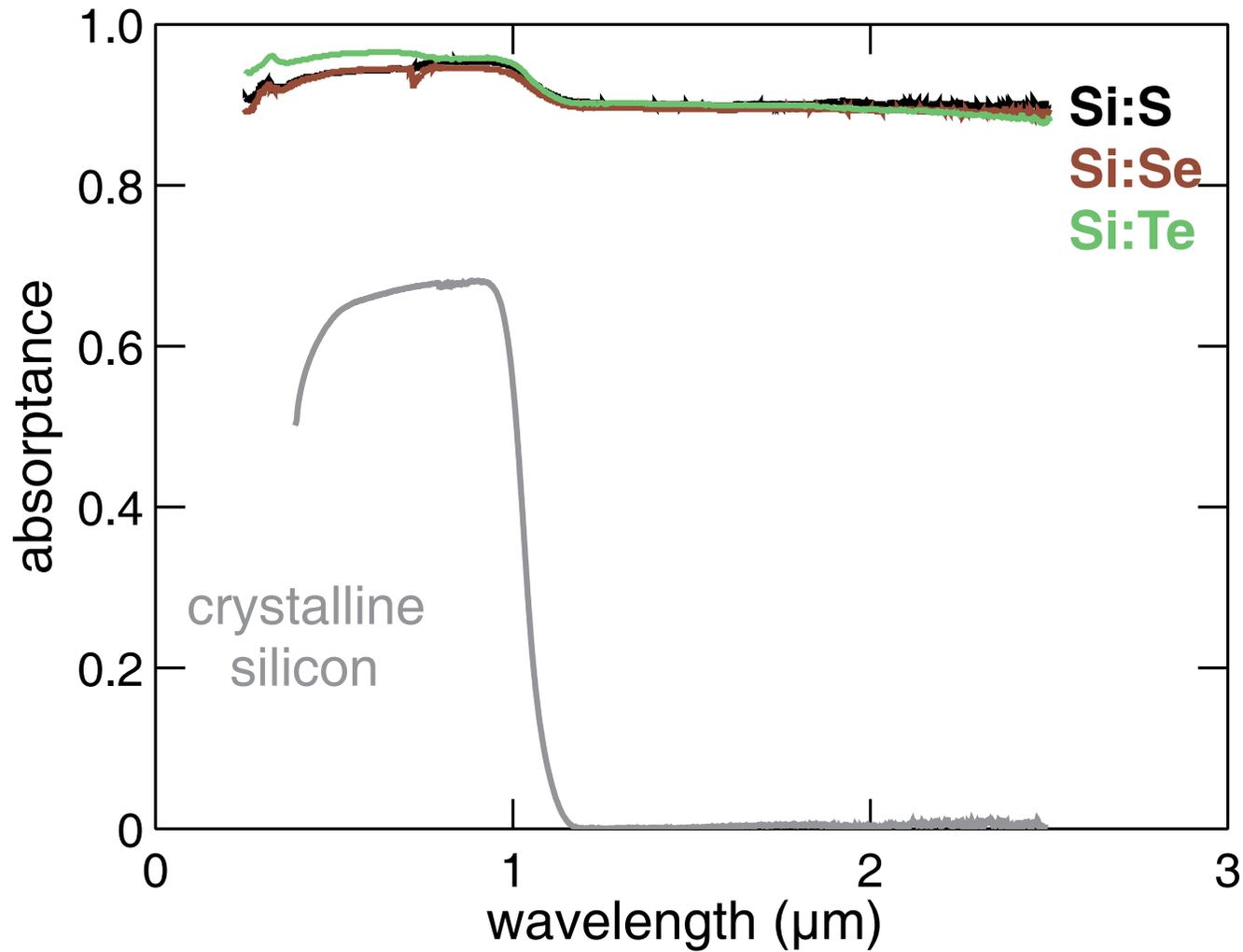
IR absorption

$$A = 1 - T_{int} - R_{int}$$



IR absorption

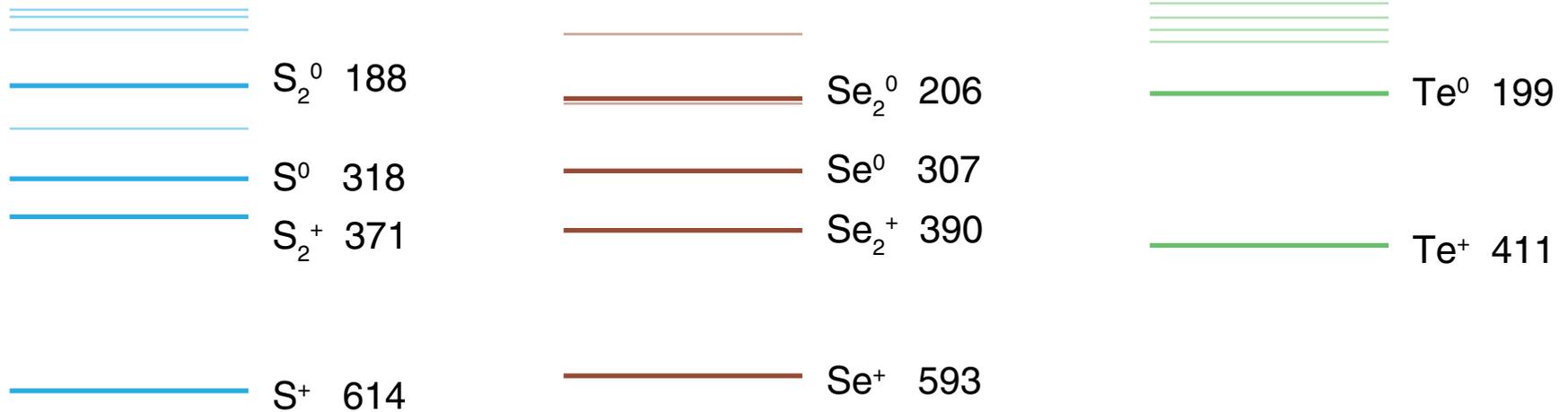
$$A = 1 - T_{int} - R_{int}$$



Mid-IR absorption

CB

0 meV

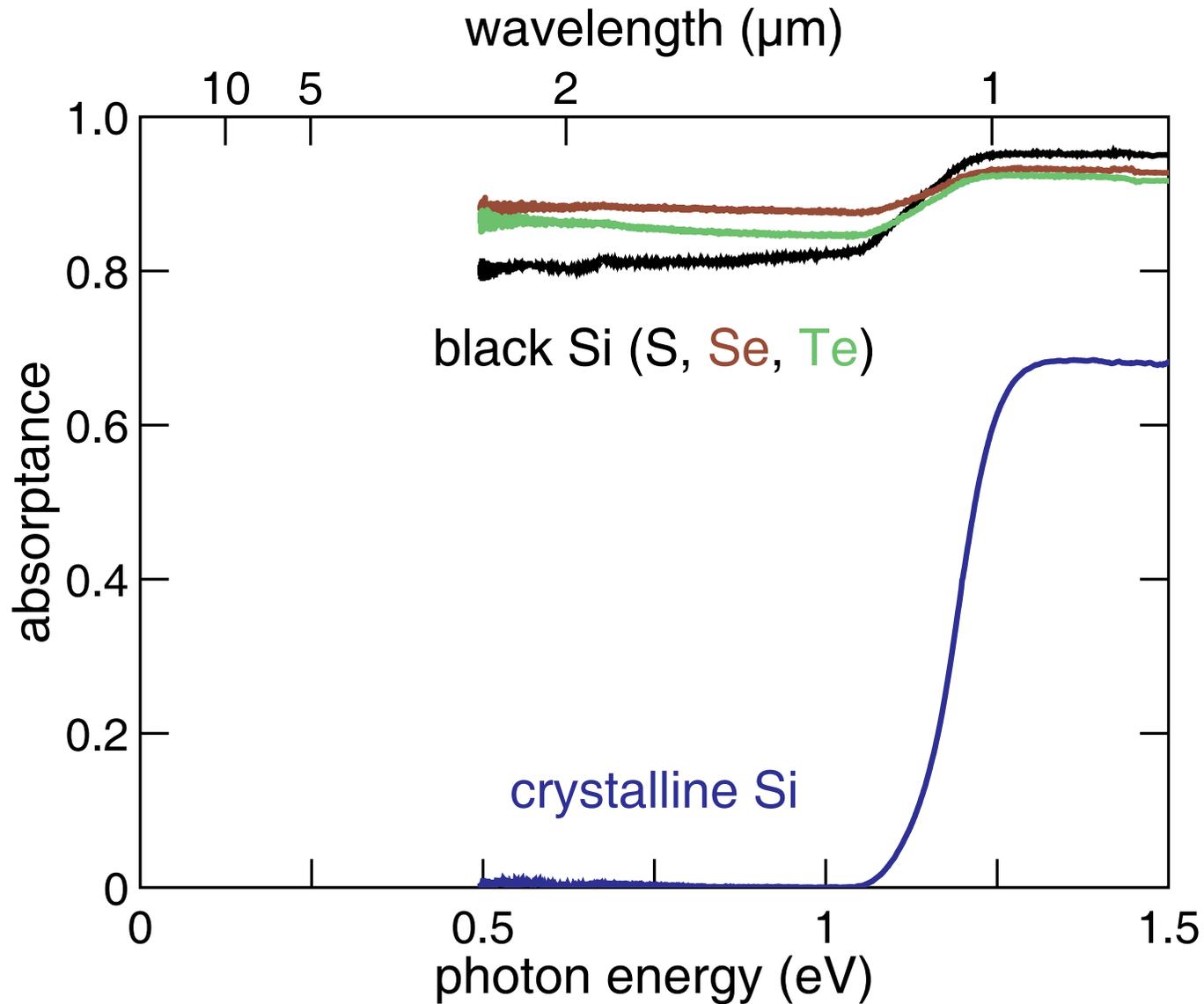


chalcogen-related energy levels in silicon
(meV below CB)

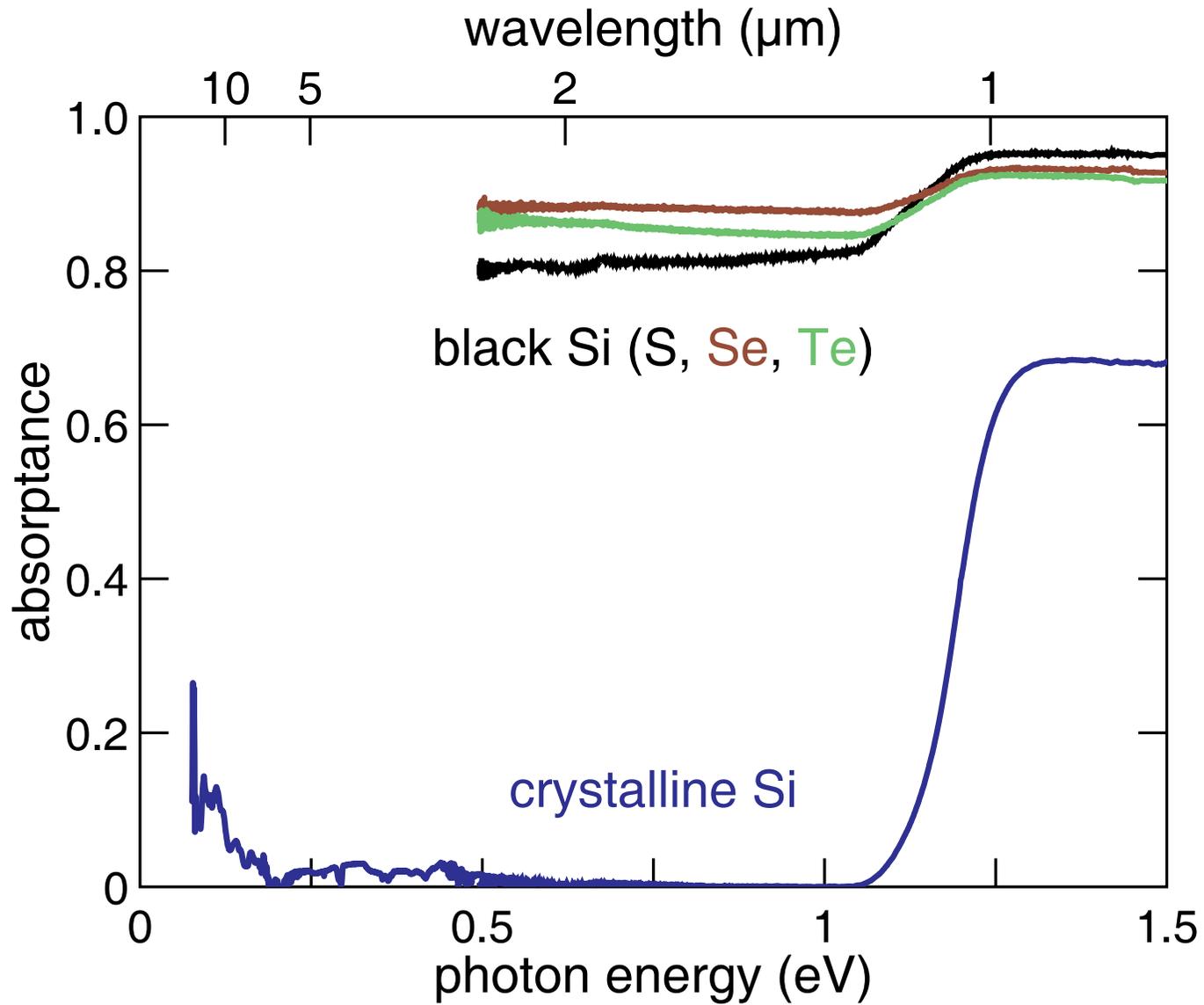
1120 meV

VB

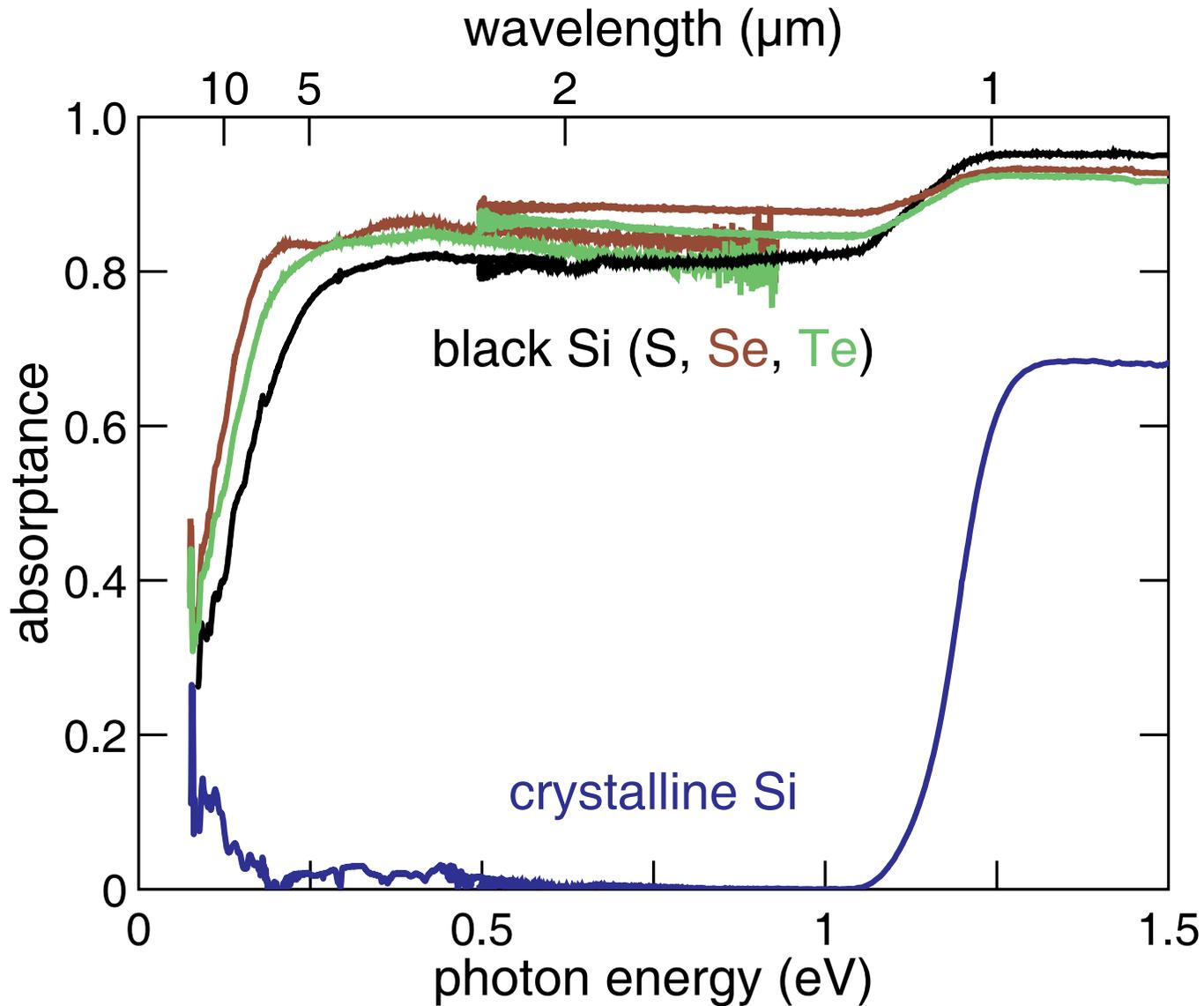
Mid-IR absorption



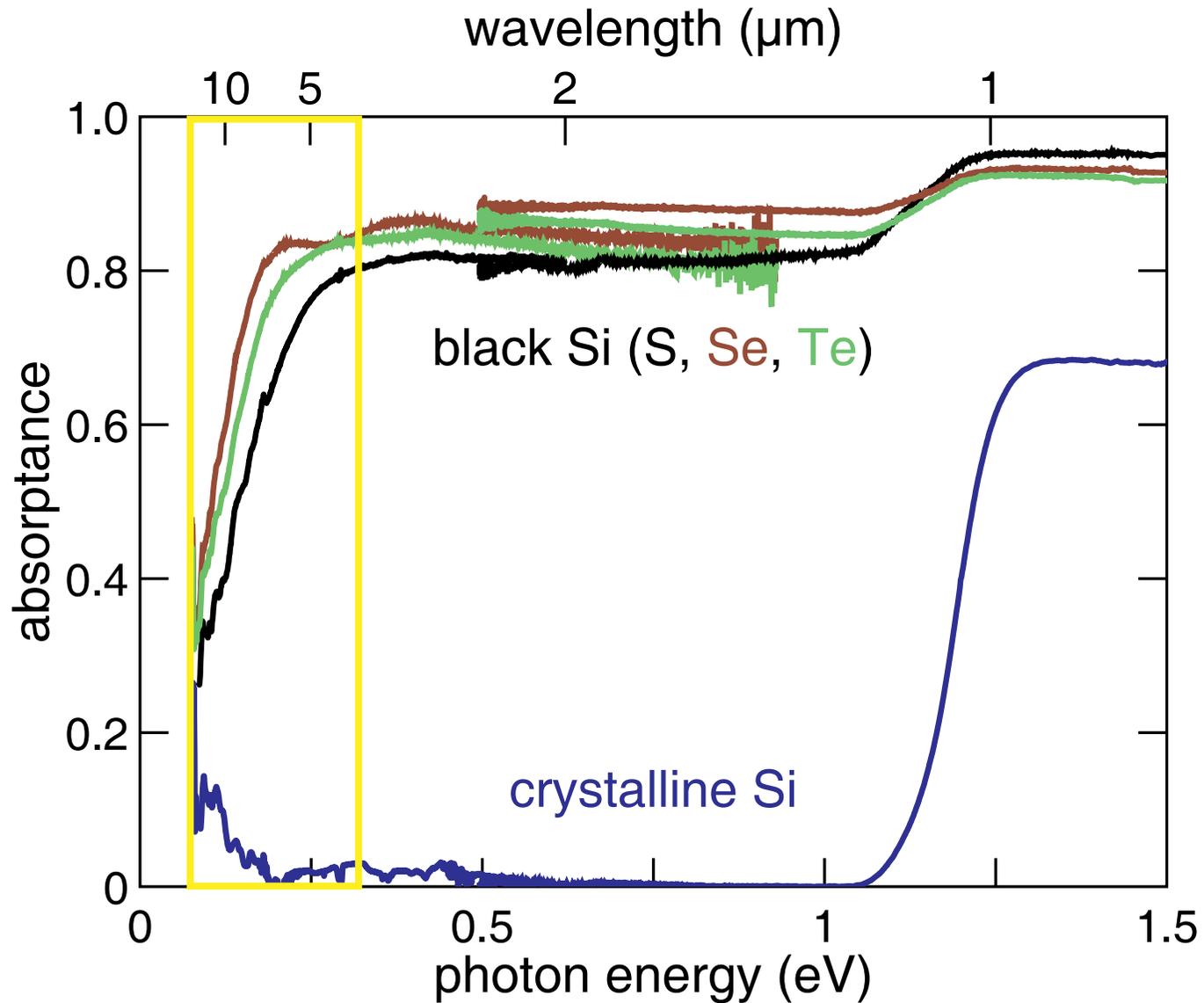
Mid-IR absorption



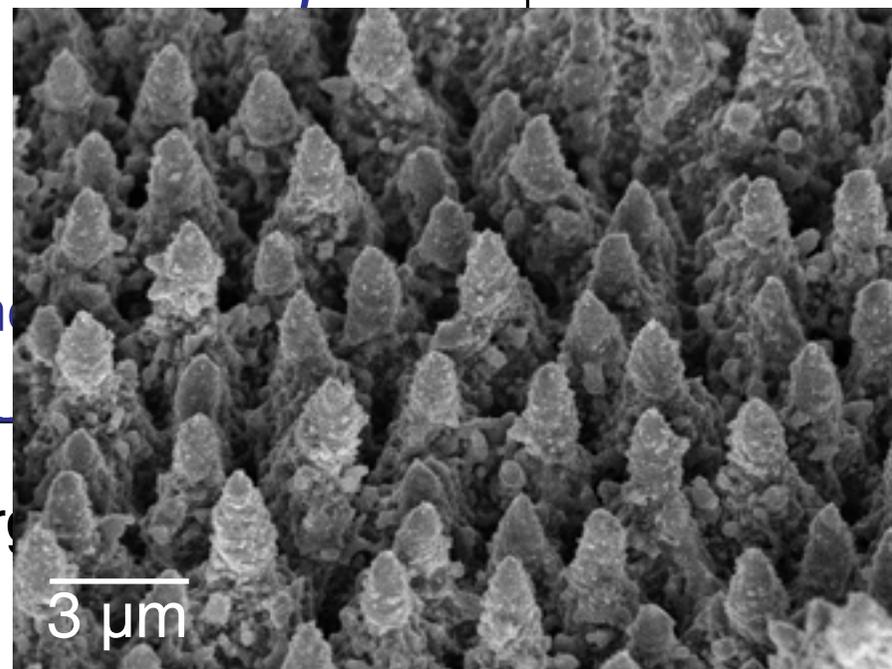
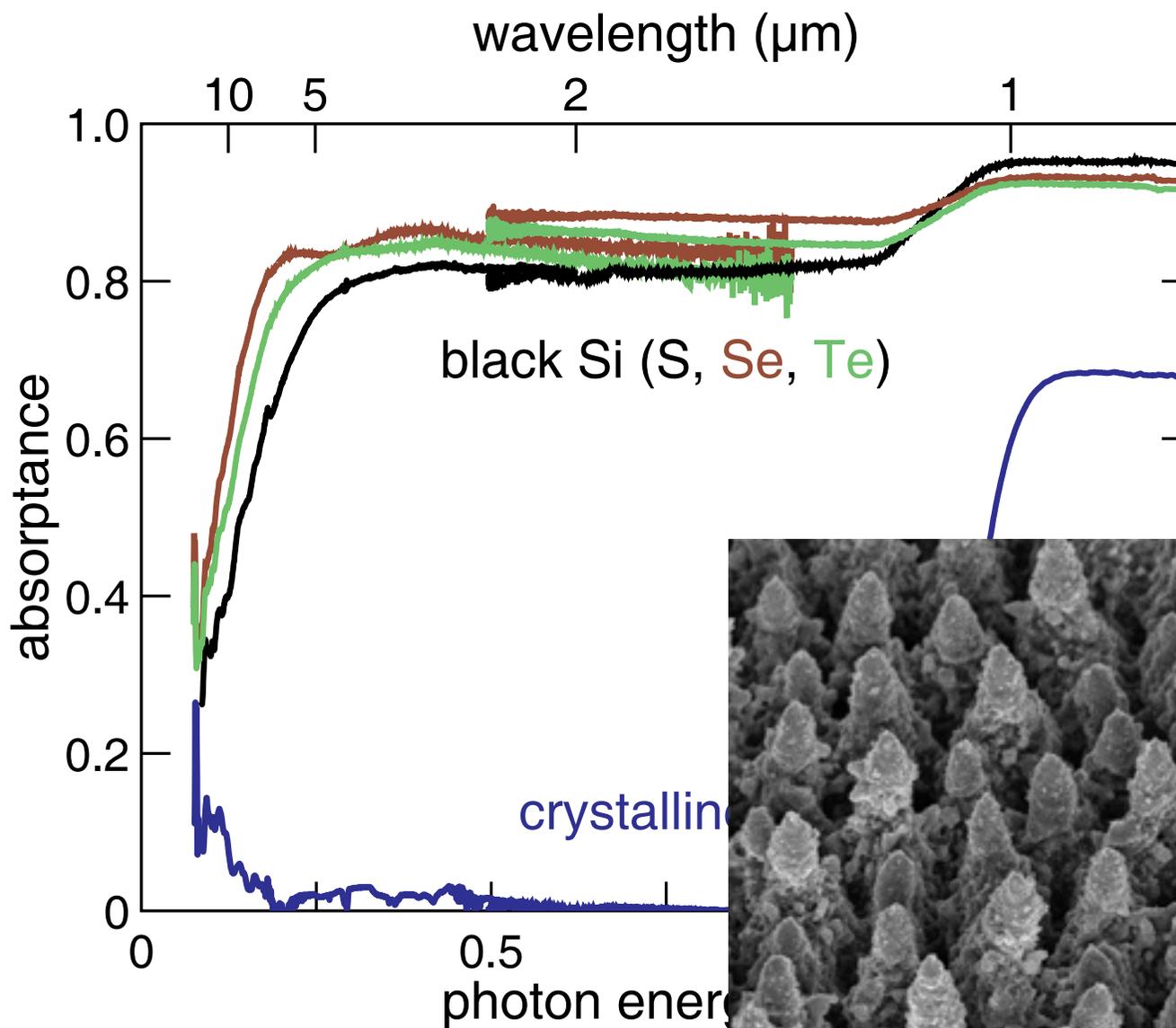
Mid-IR absorption



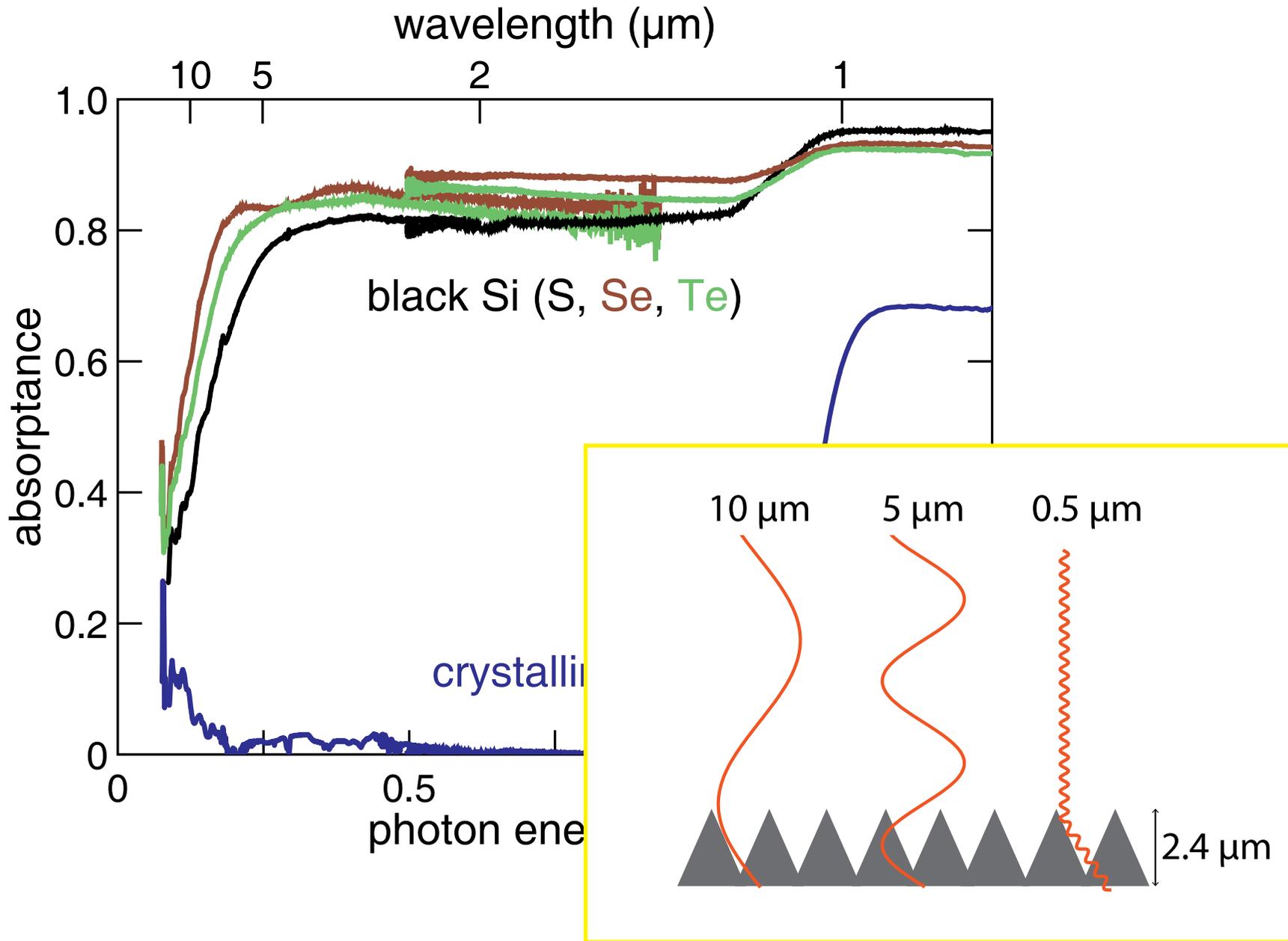
Mid-IR absorption



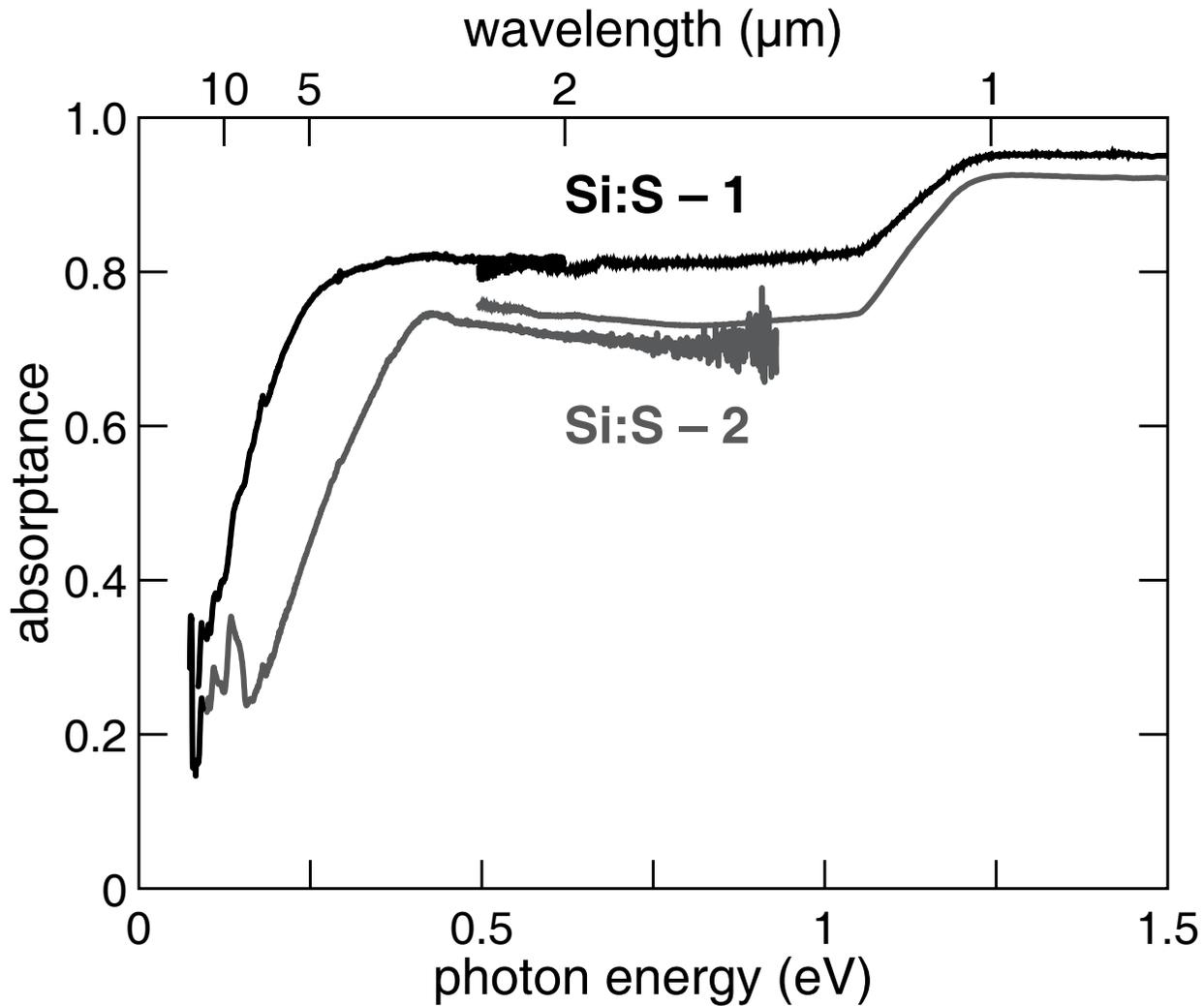
Mid-IR absorption



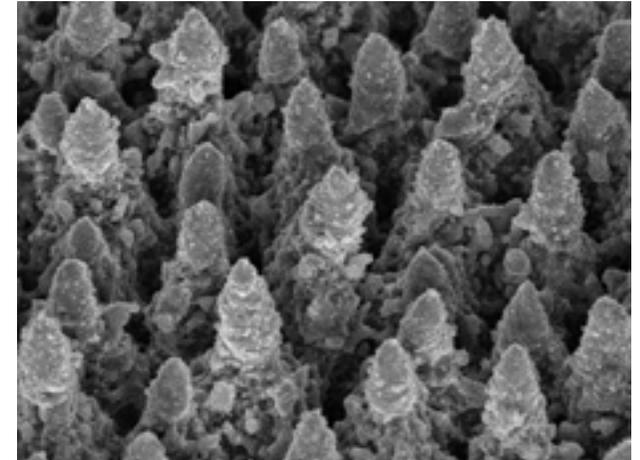
Mid-IR absorption



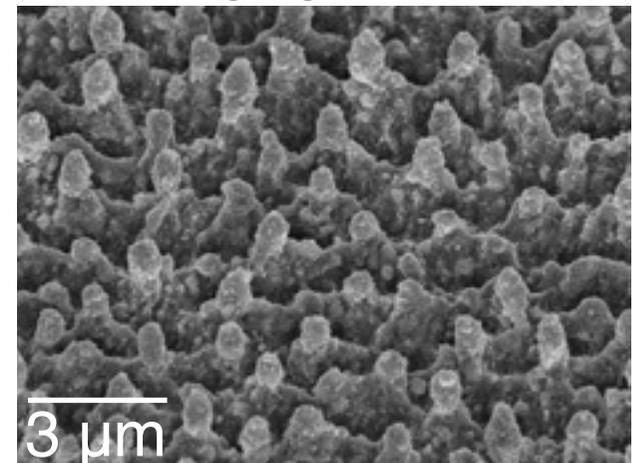
Mid-IR absorption



Si:S – 1

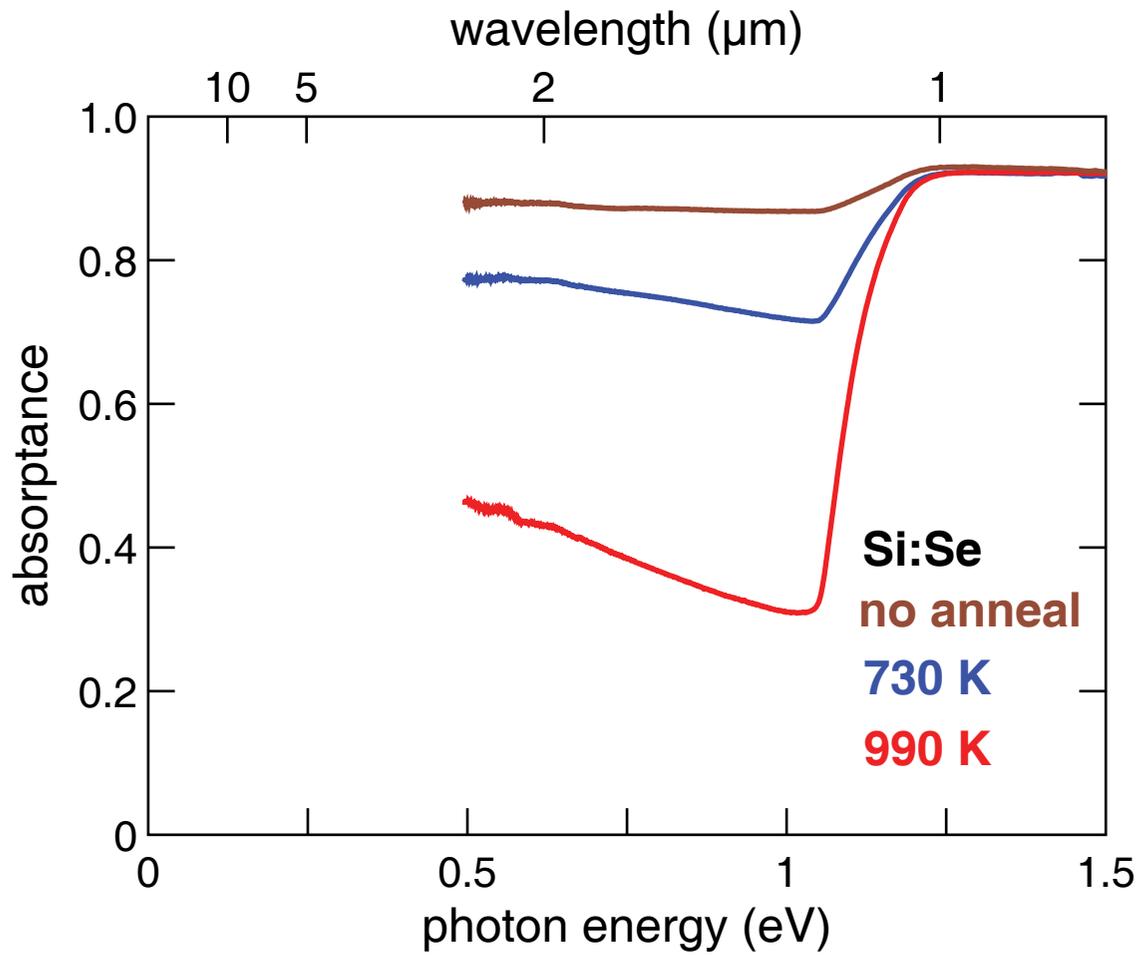


Si:S – 2

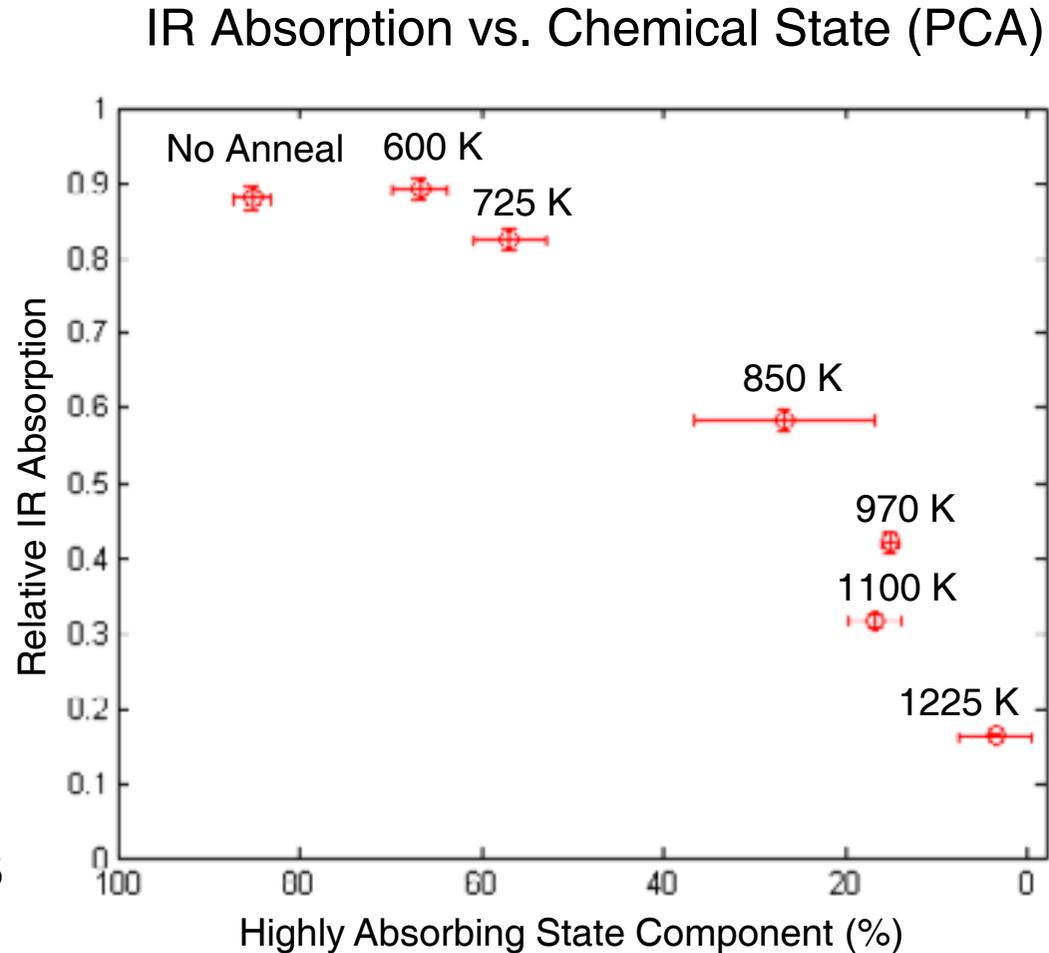
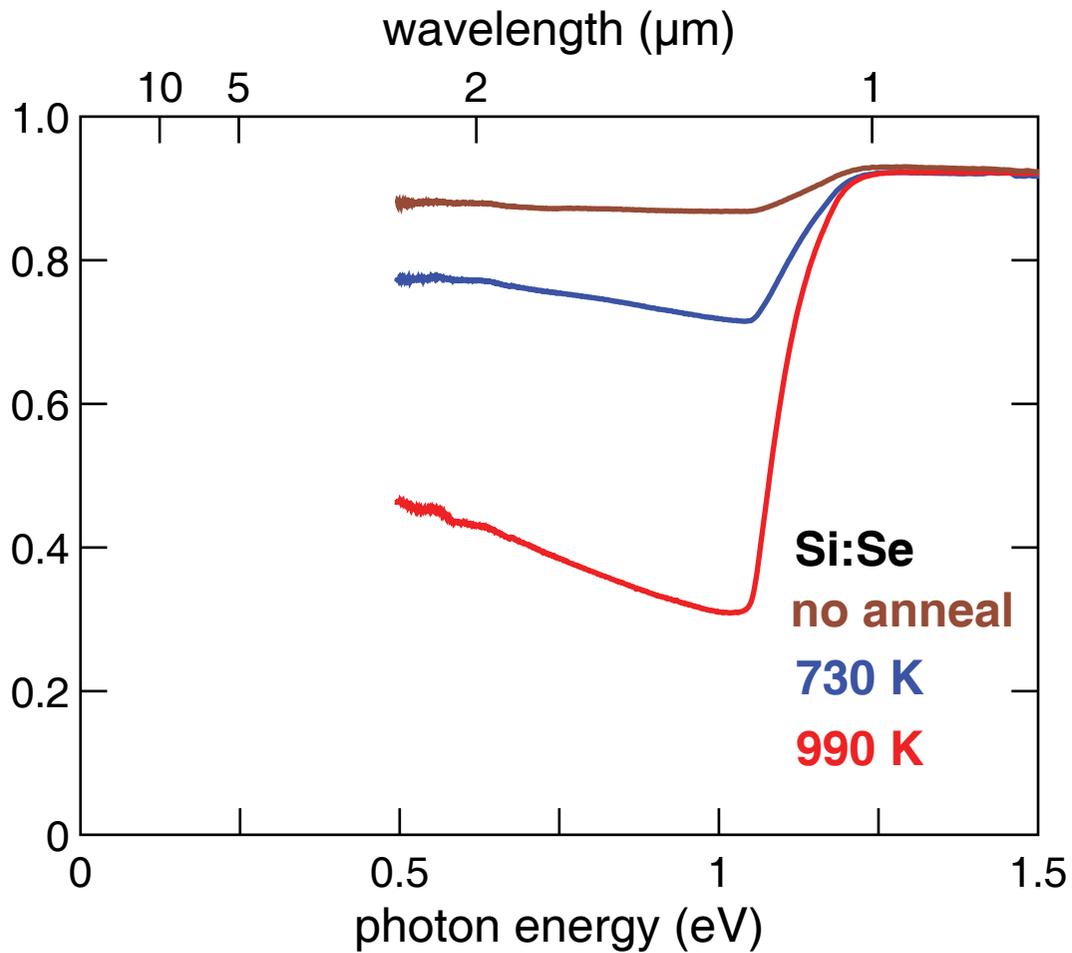


changing surface roughness

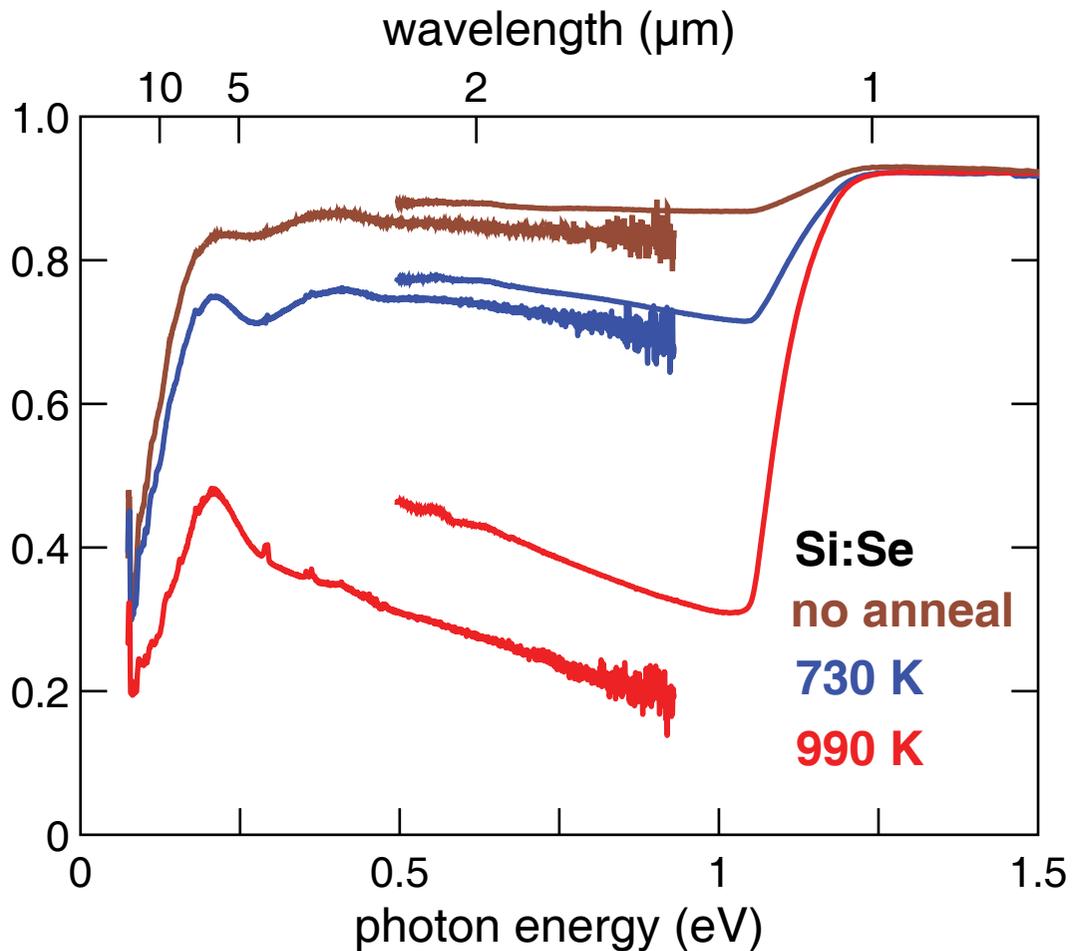
Dopant diffusion



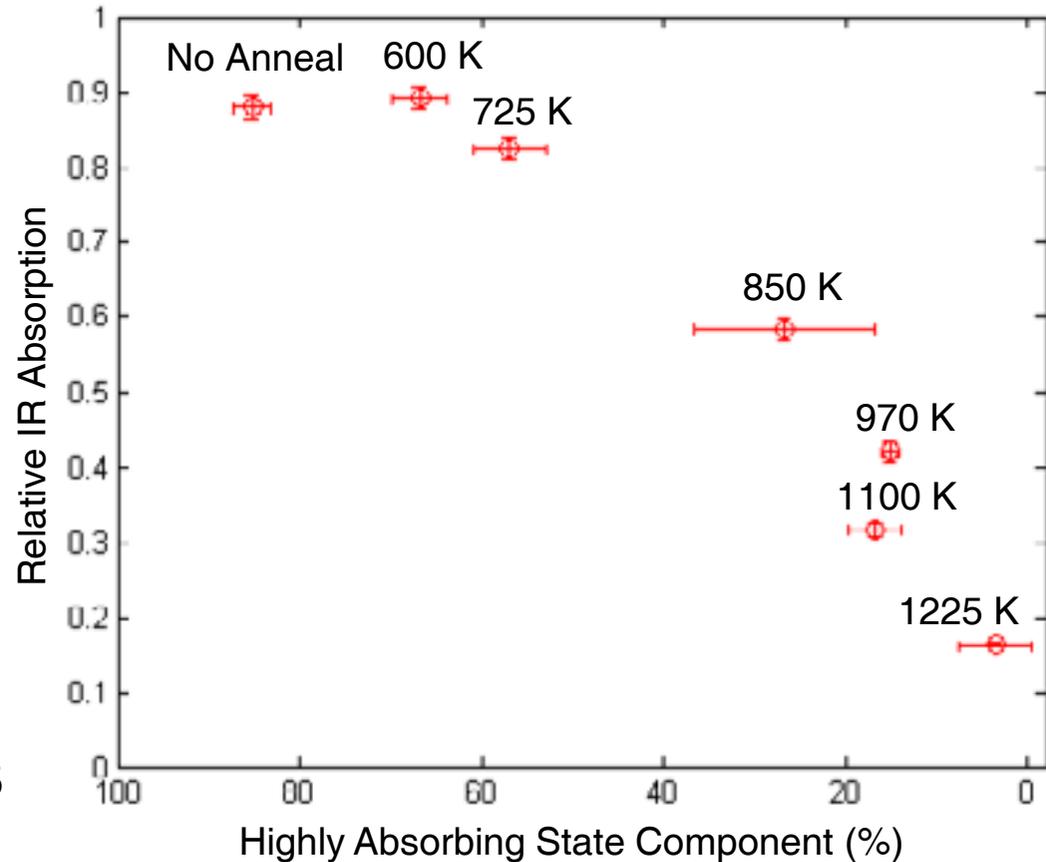
Dopant diffusion



Dopant diffusion



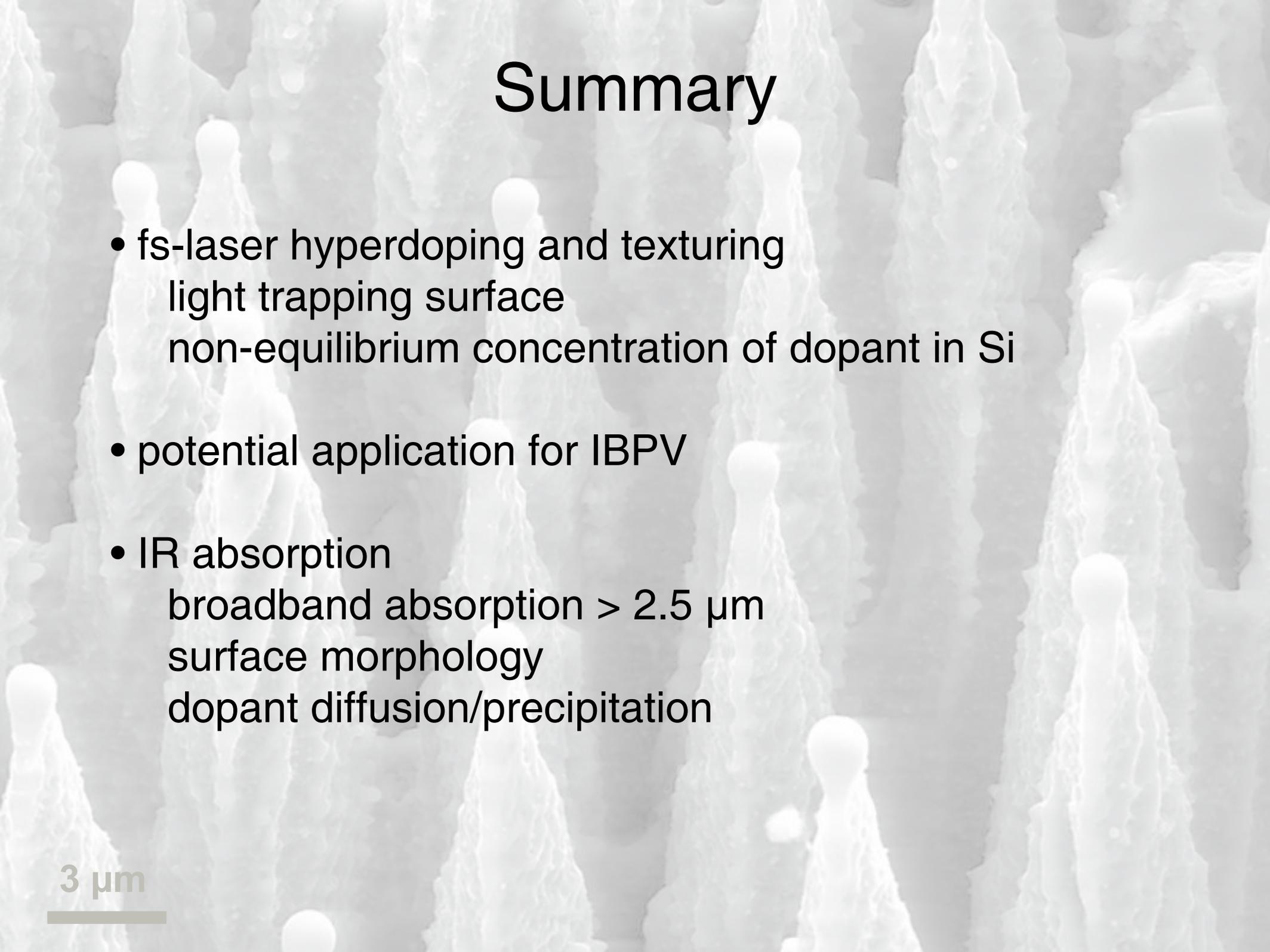
IR Absorption vs. Chemical State (PCA)



Summary

- fs-laser hyperdoping and texturing
light trapping surface
non-equilibrium concentration of dopant in Si
- potential application for IBPV
- IR absorption
broadband absorption $> 2.5 \mu\text{m}$
surface morphology
dopant diffusion/precipitation

3 μm

The background of the slide is a grayscale scanning electron microscope (SEM) image of a surface with a complex, porous, and textured morphology. The surface consists of numerous interconnected, elongated, and somewhat cylindrical structures that create a highly irregular and porous appearance. A horizontal scale bar is located in the bottom-left corner, labeled '3 μm'.

Thanks!



Harvard University
Center for
Nanoscale
Systems



Thanks!



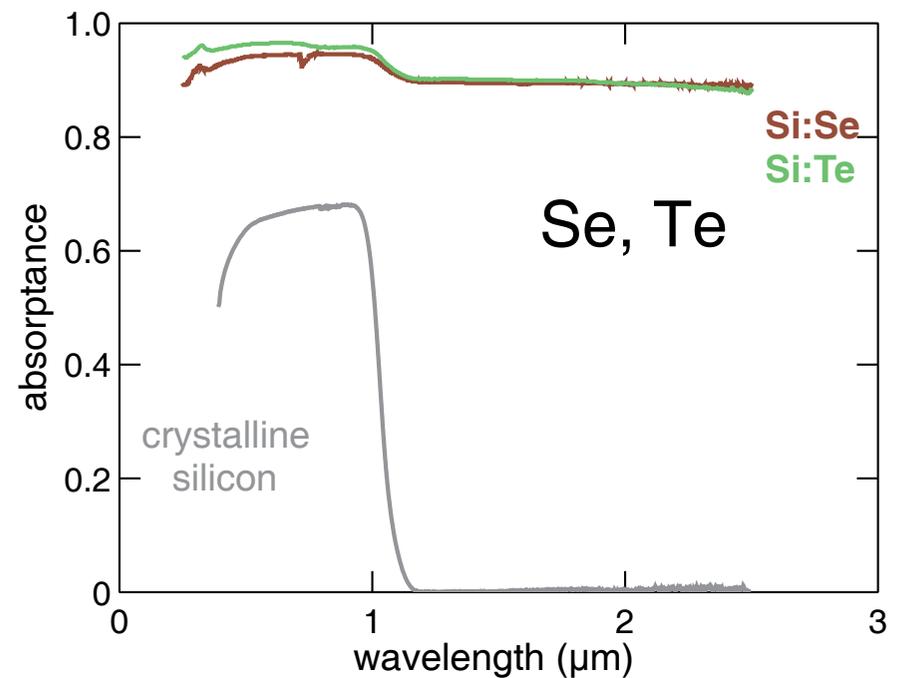
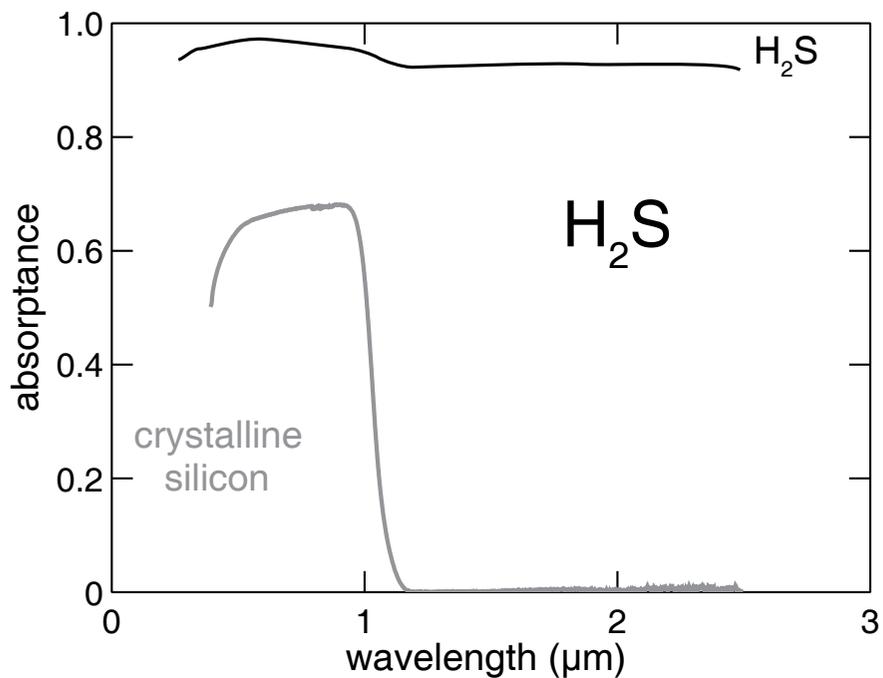
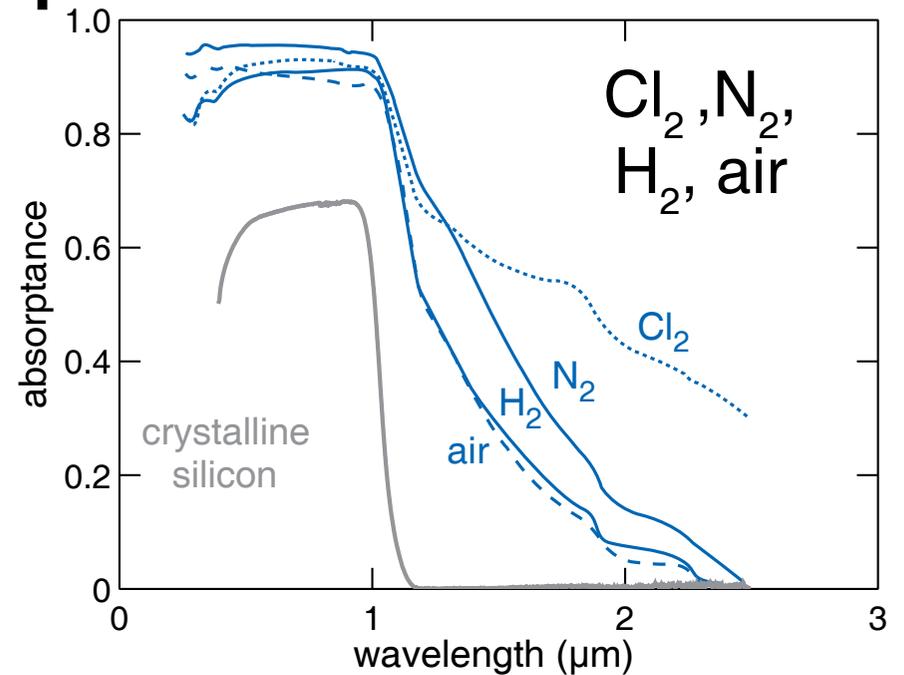
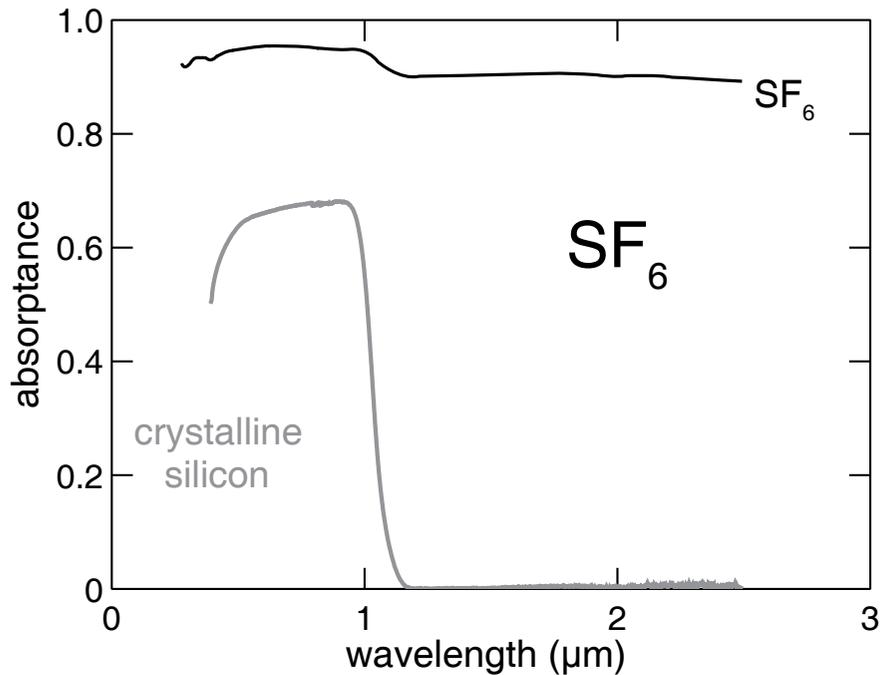
Questions?

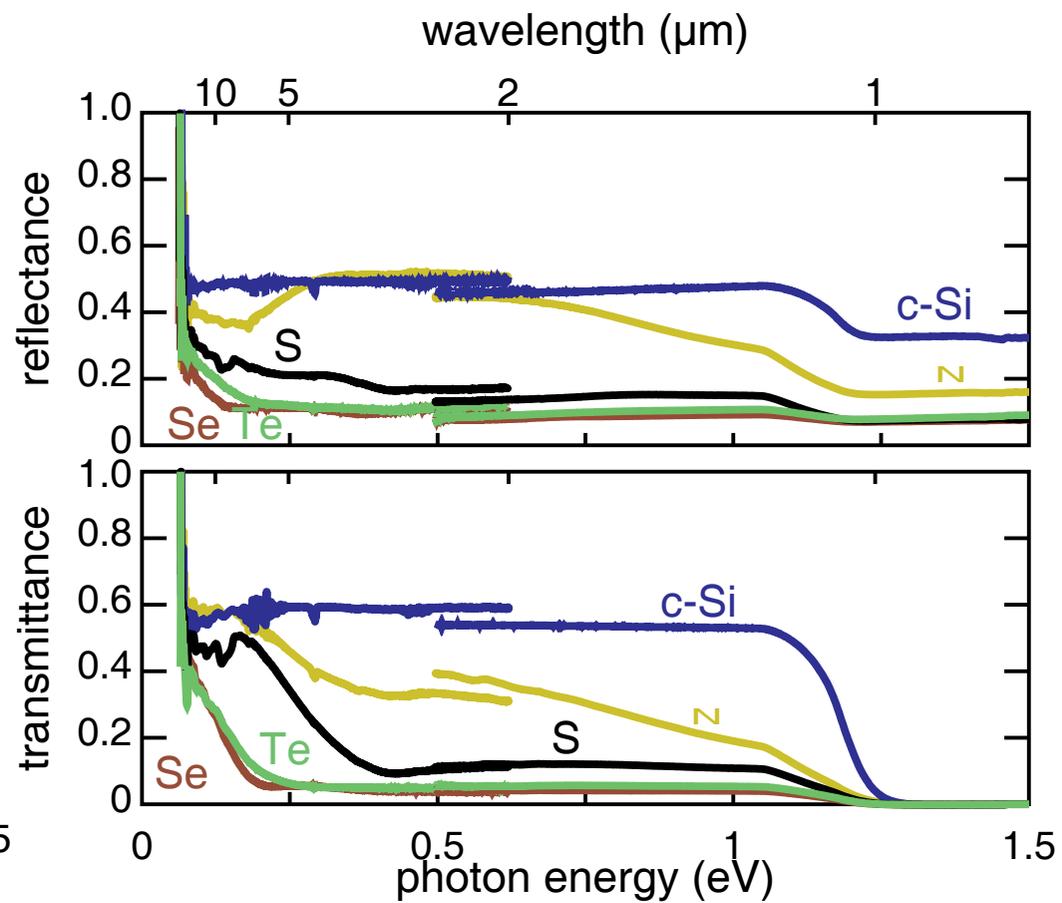
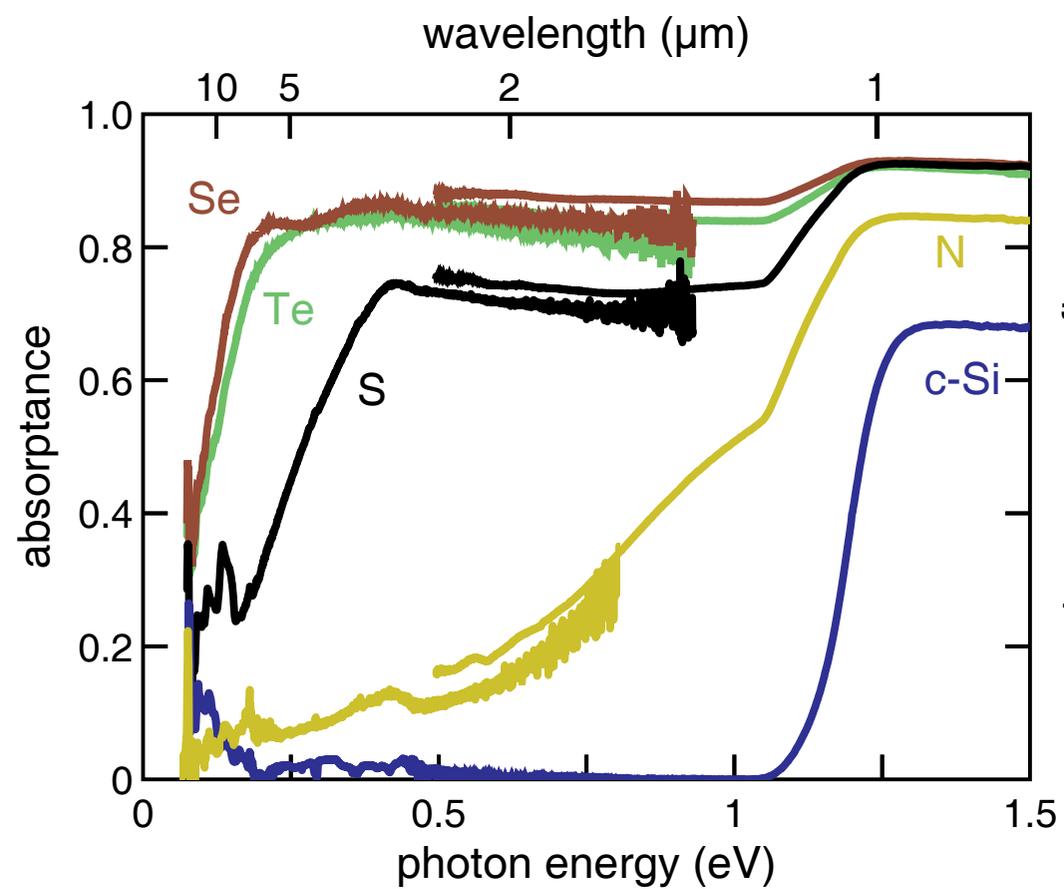
sher@physics.harvard.edu

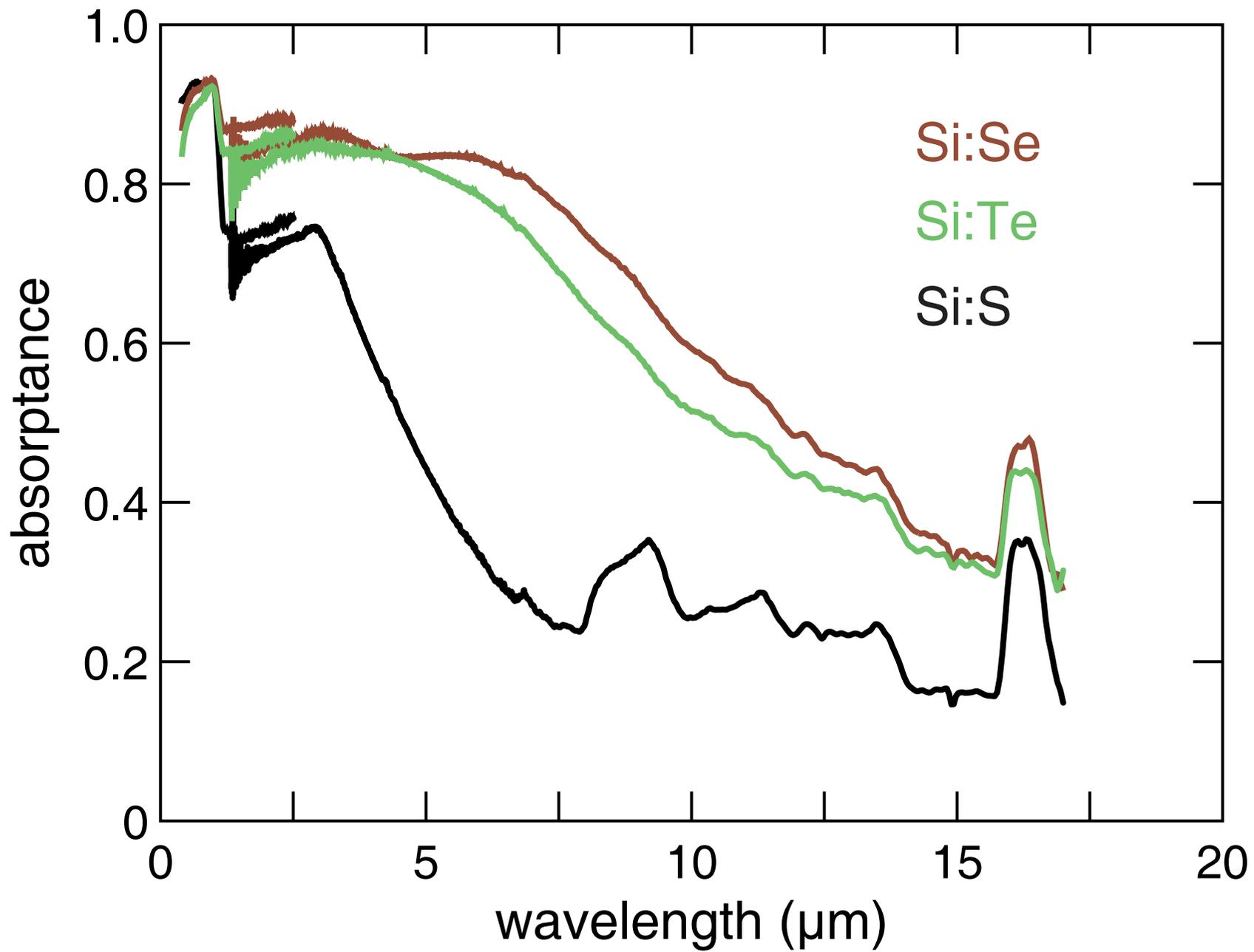
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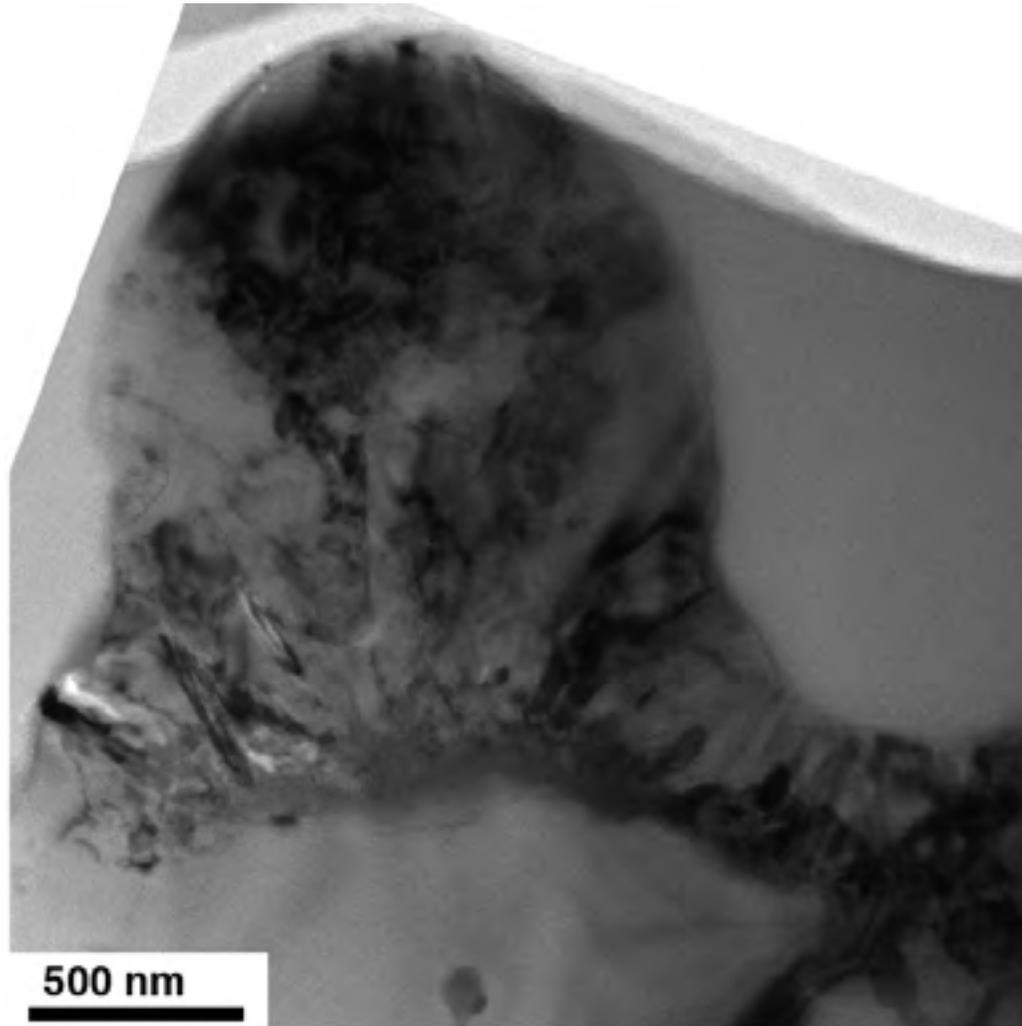


IR absorption









TEM Si:Se

responsivity

